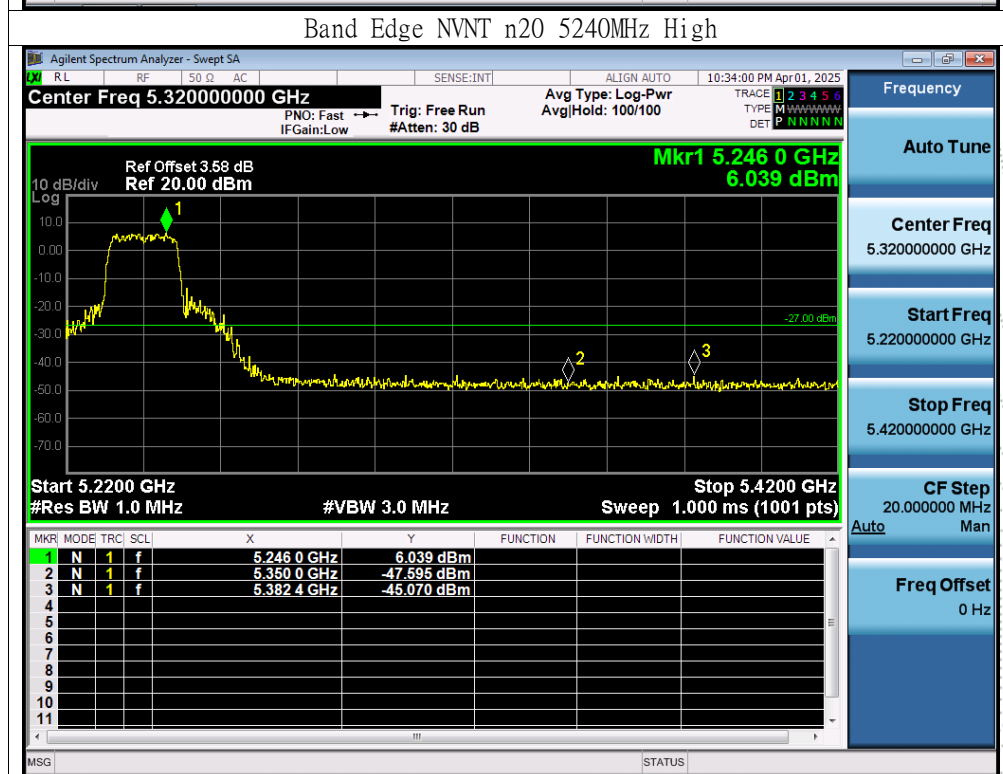
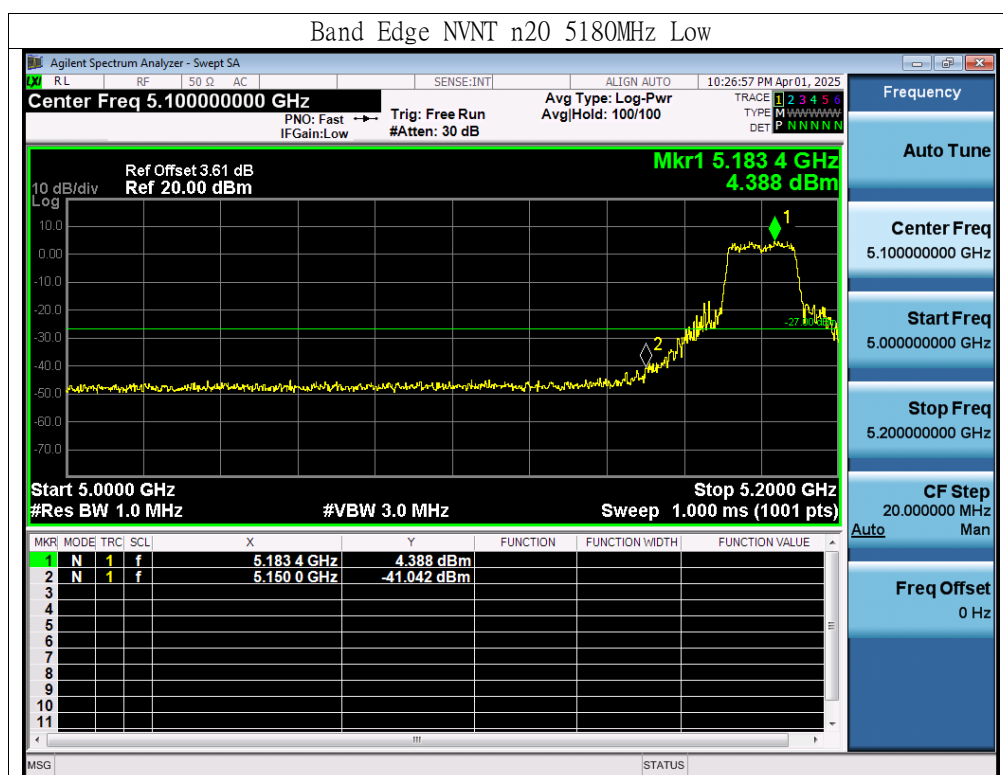
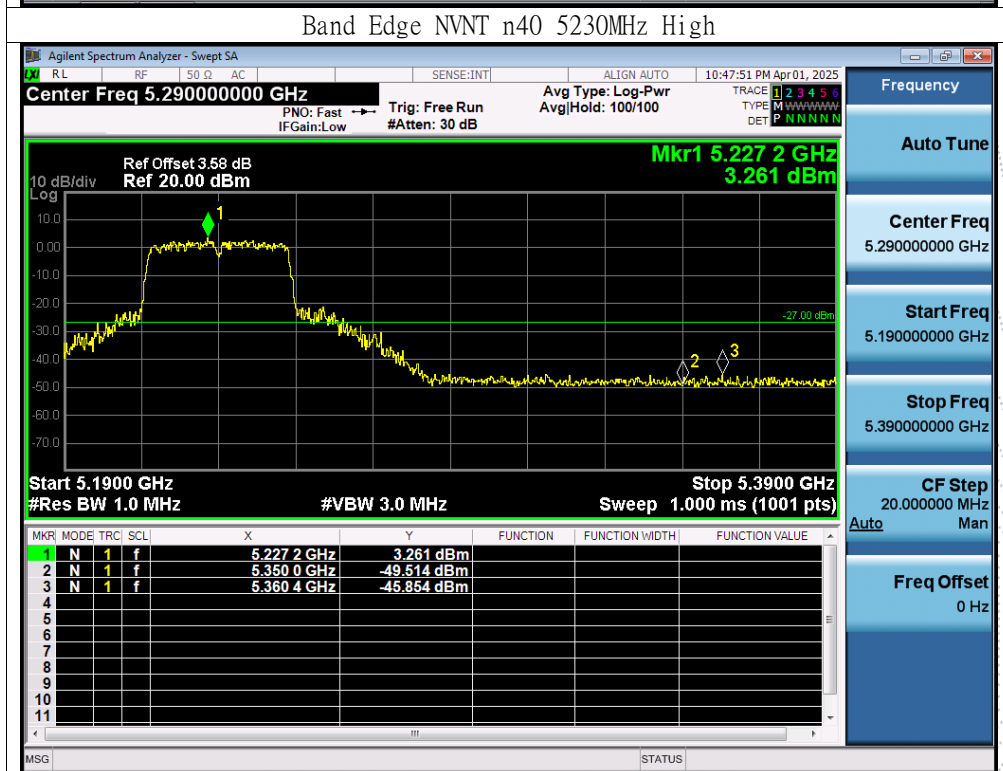
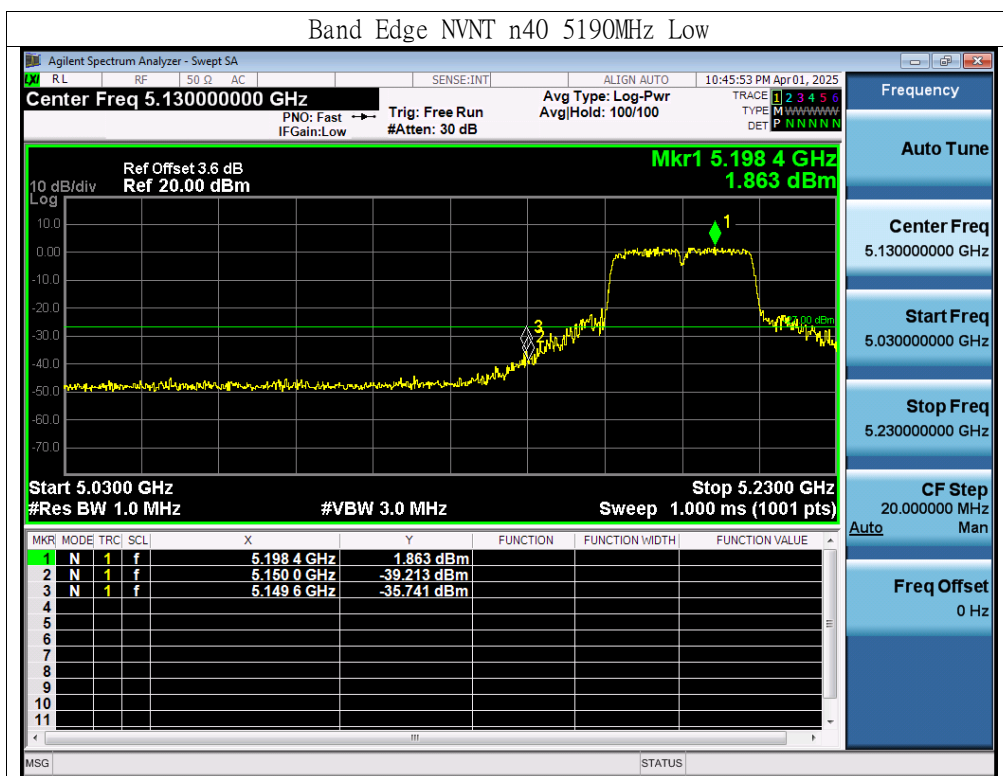
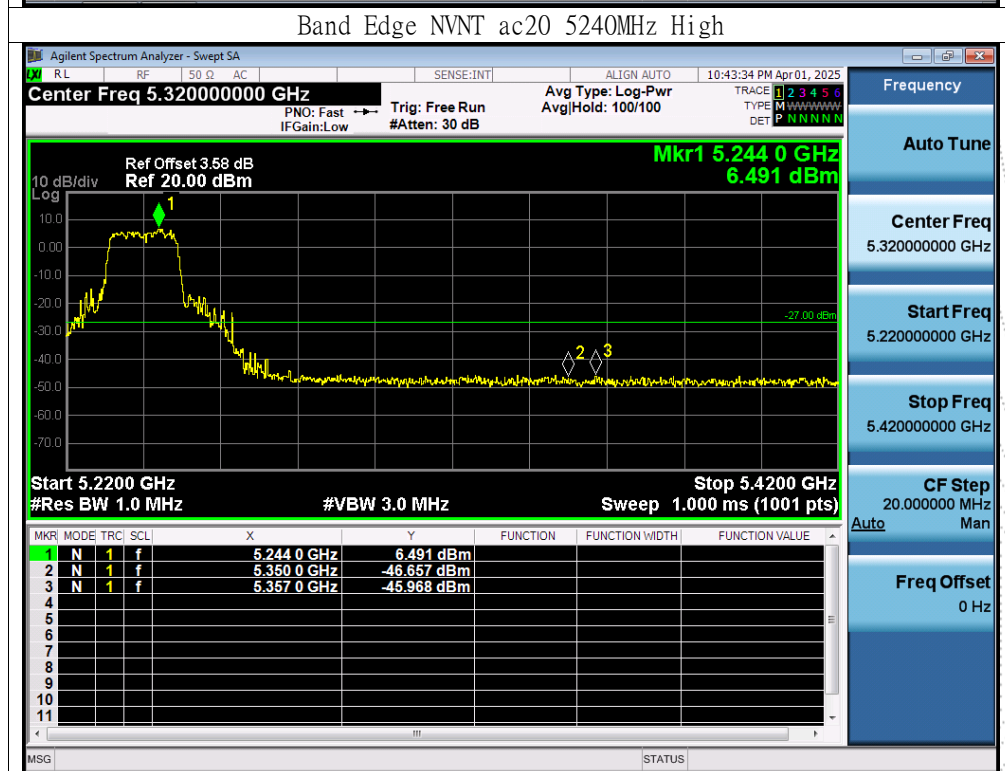
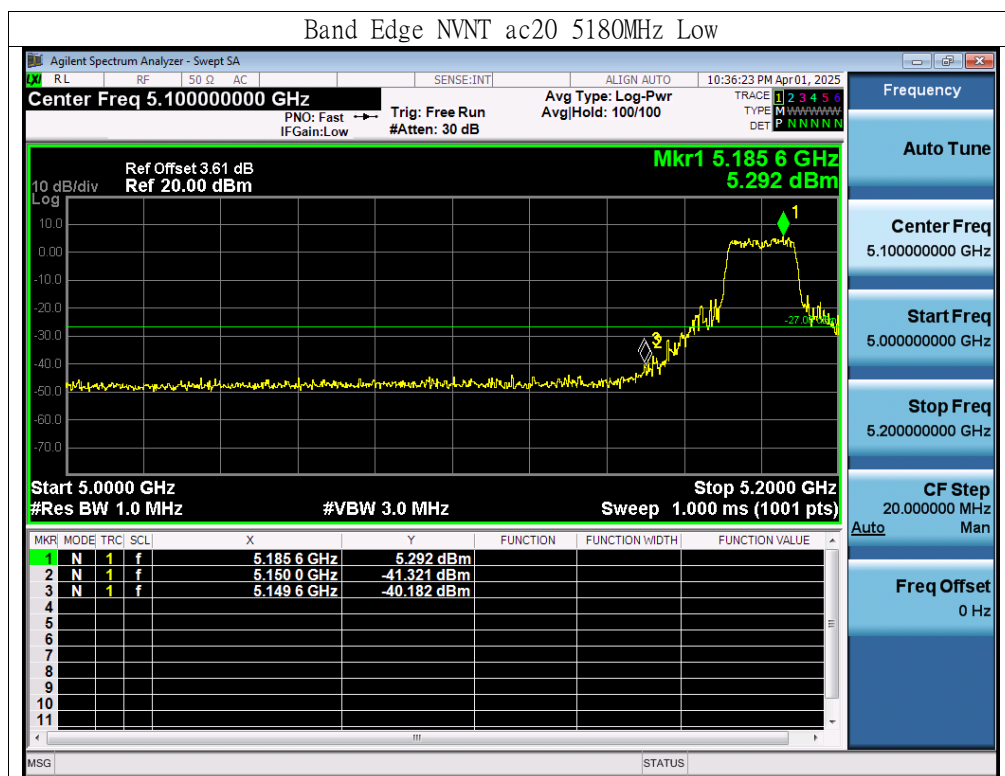
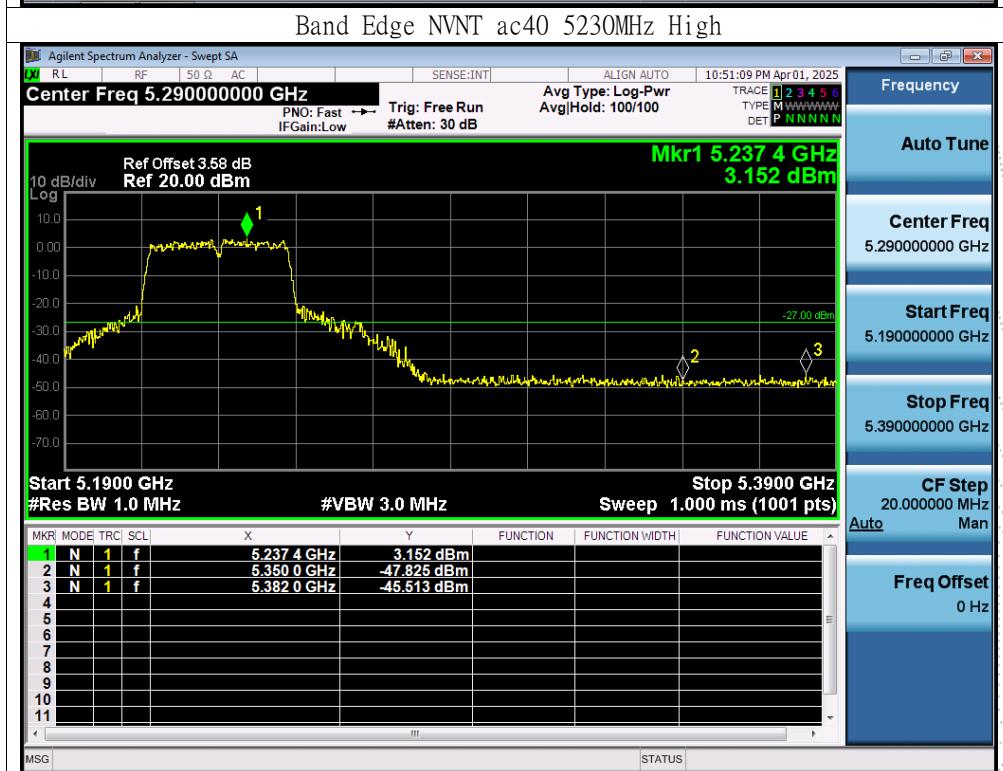
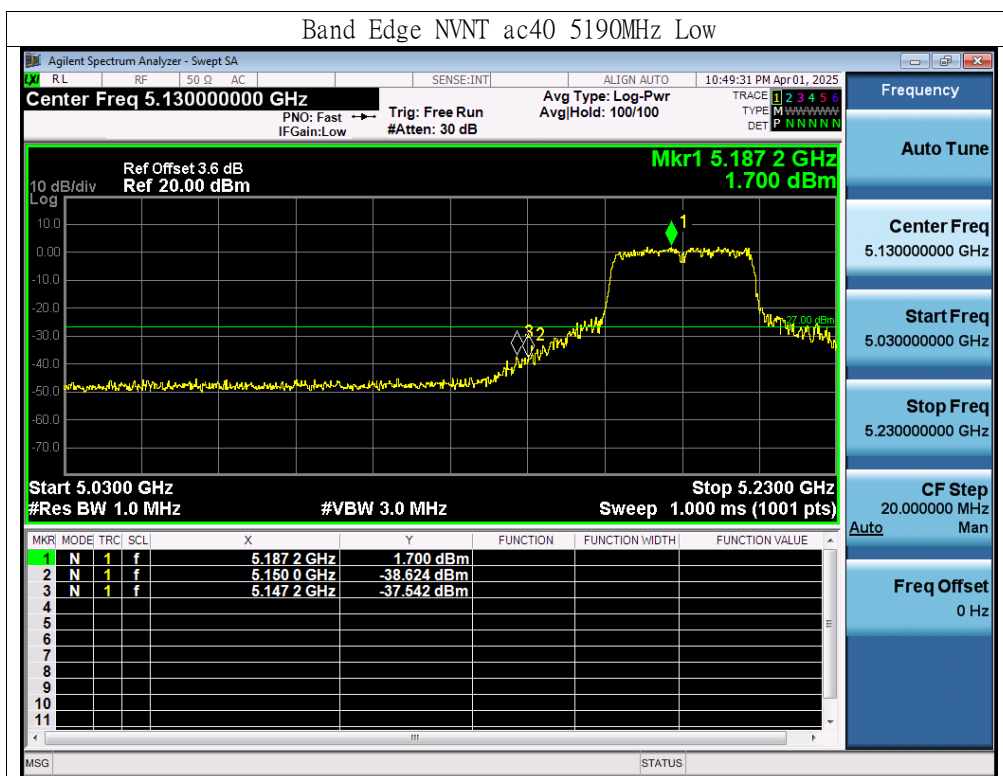
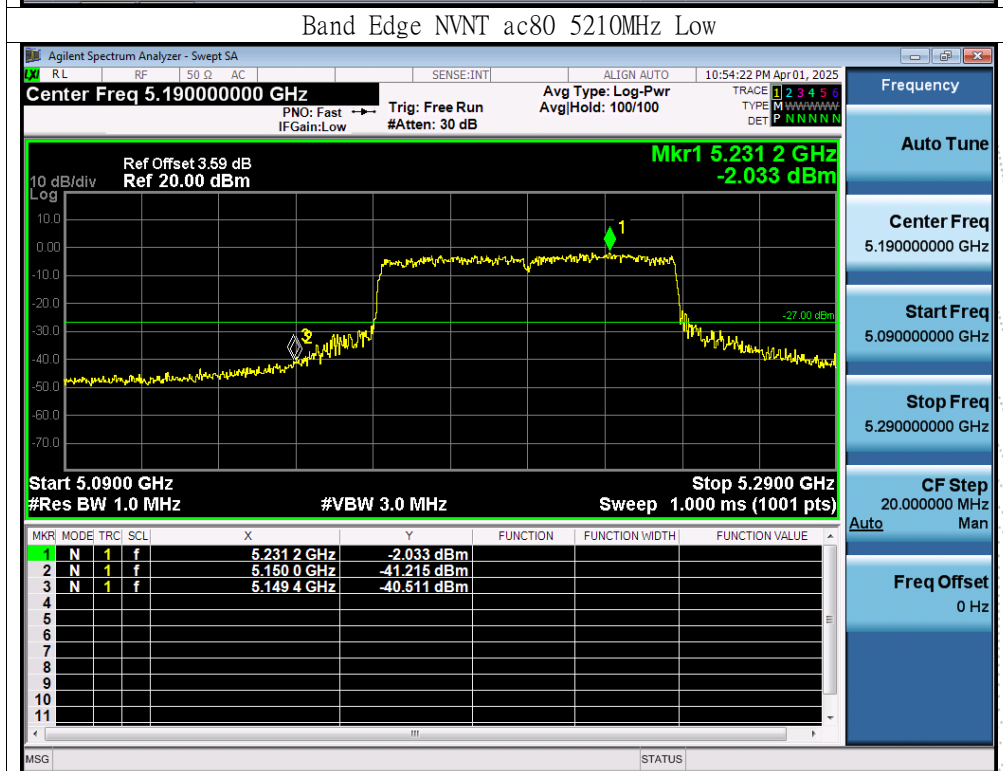
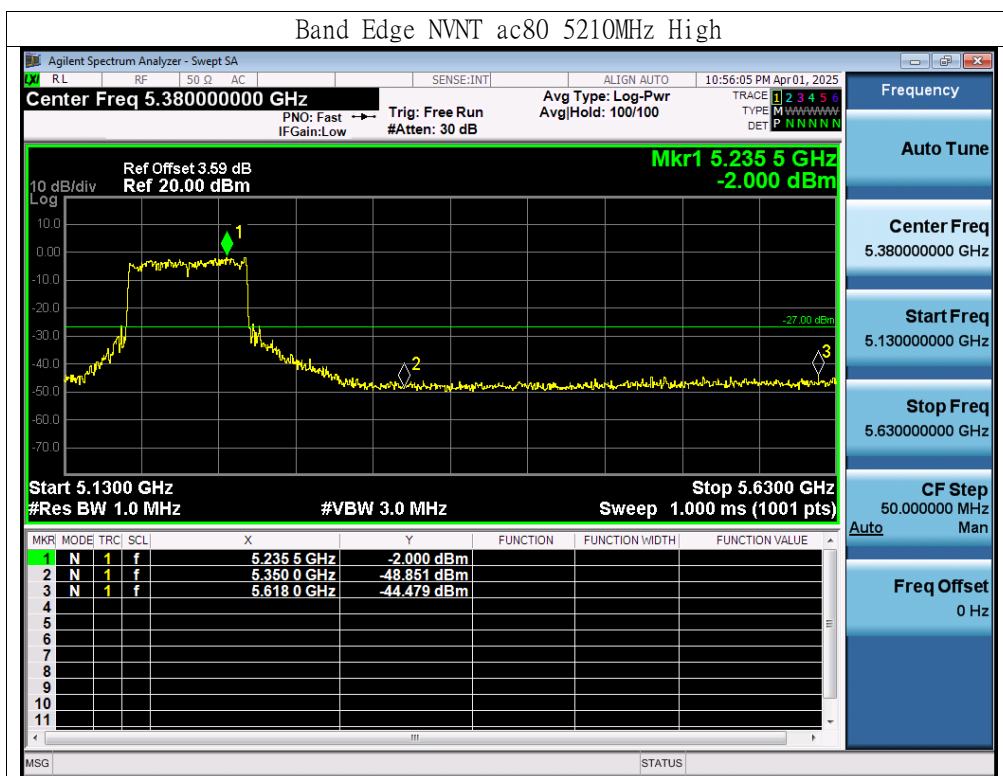


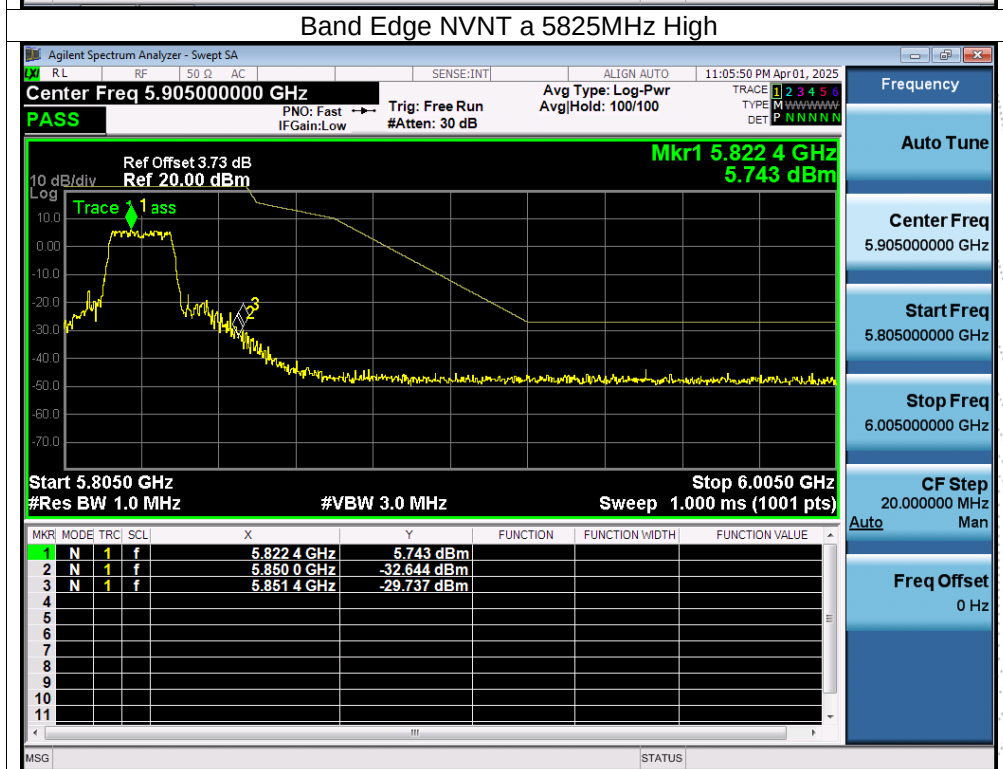
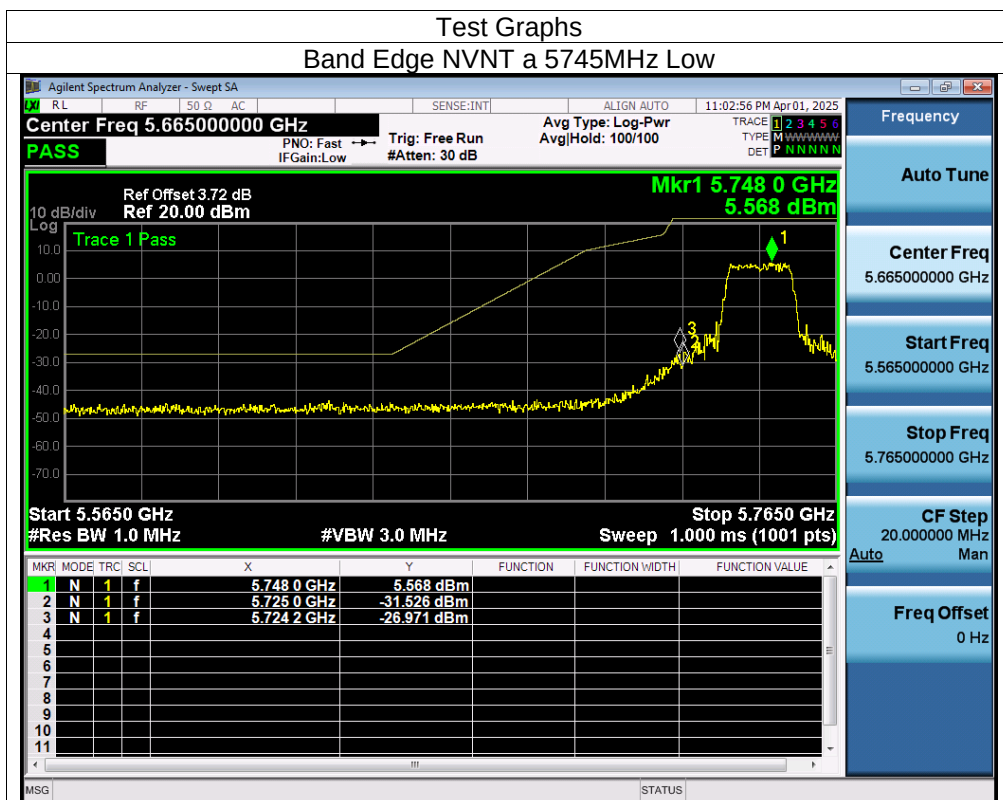


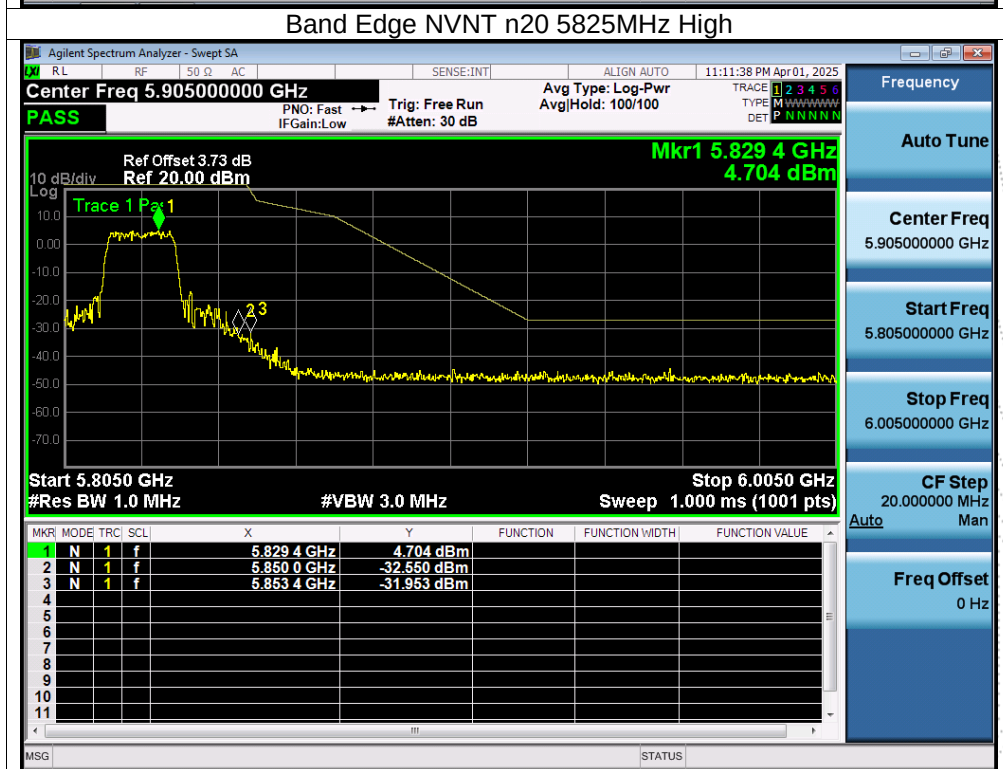
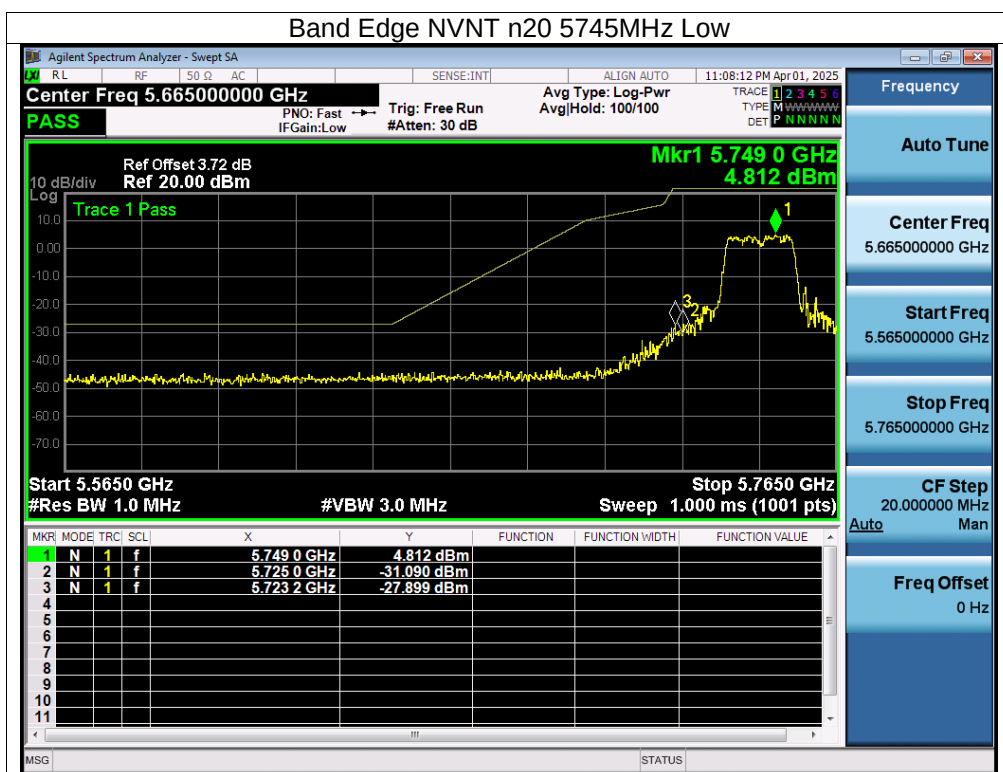


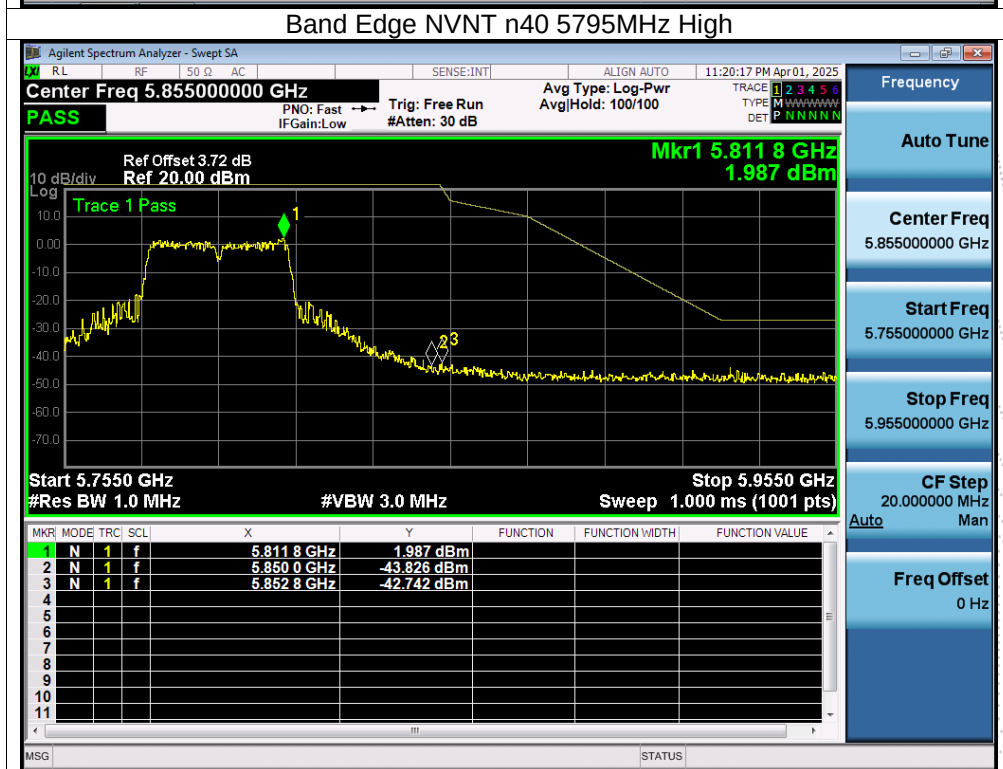
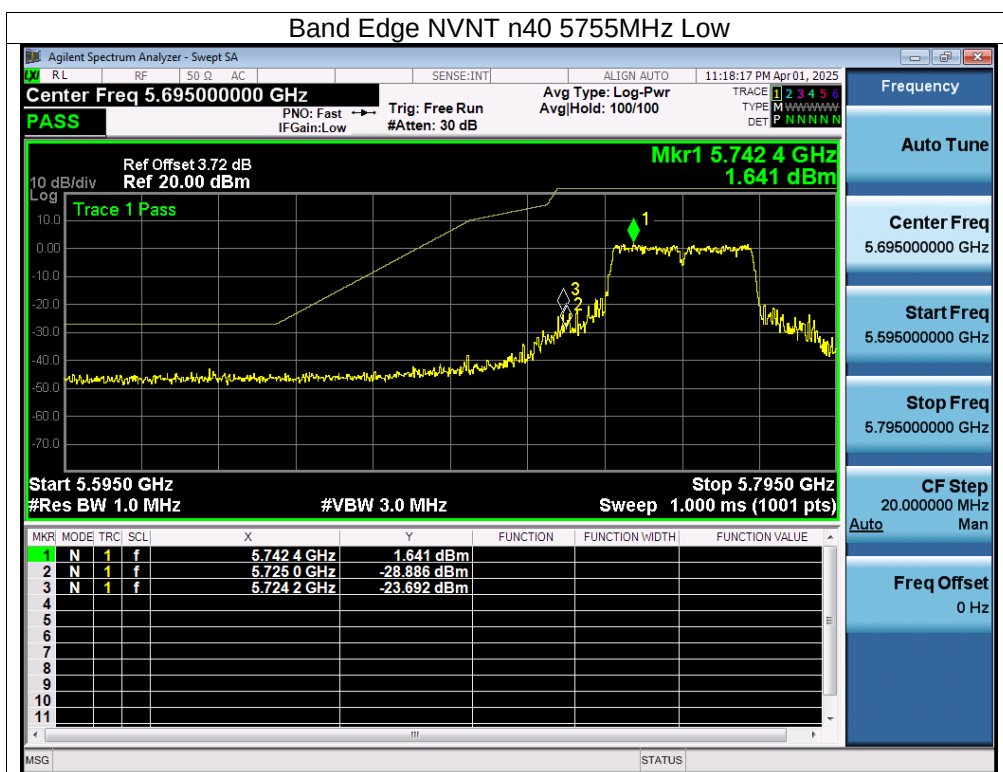


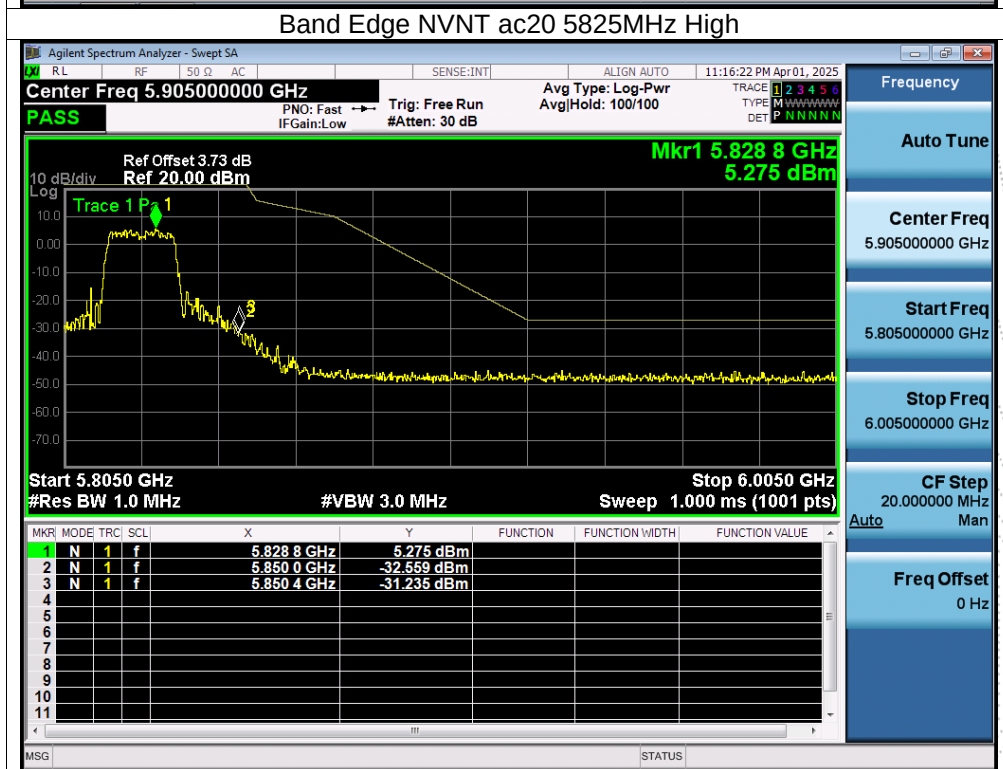
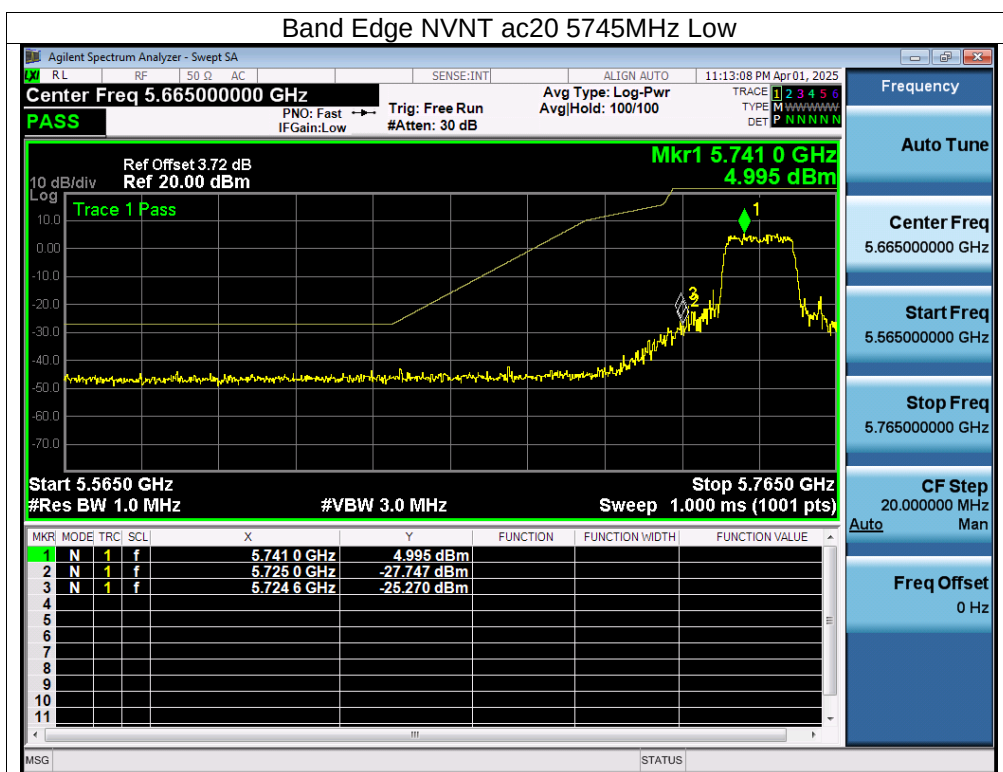


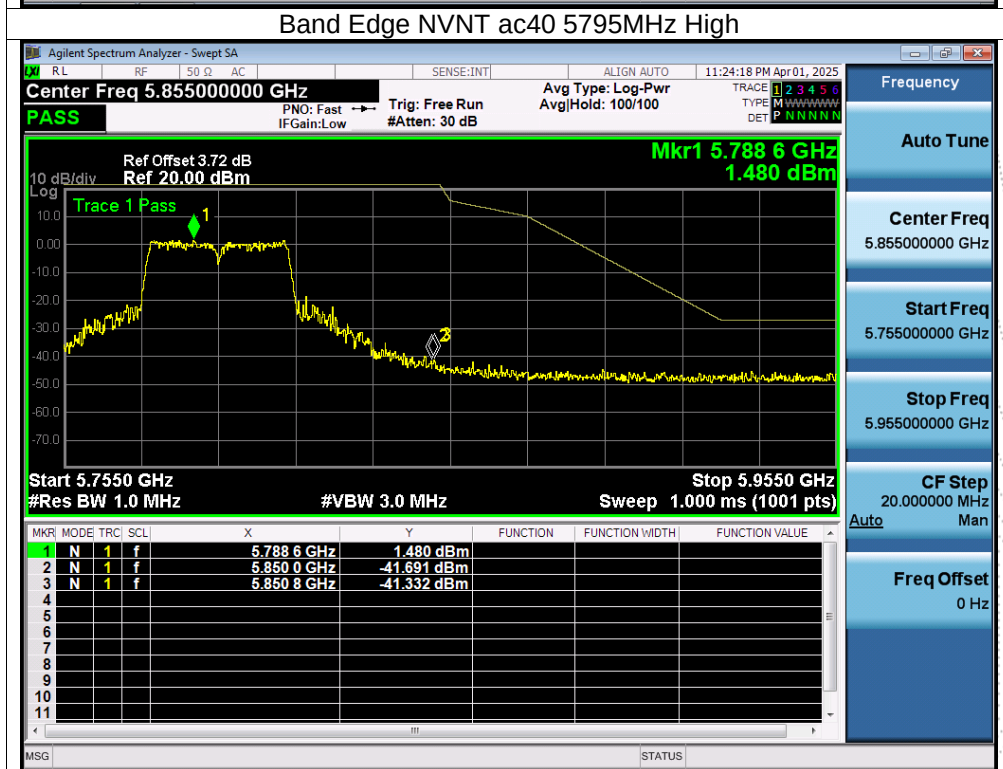
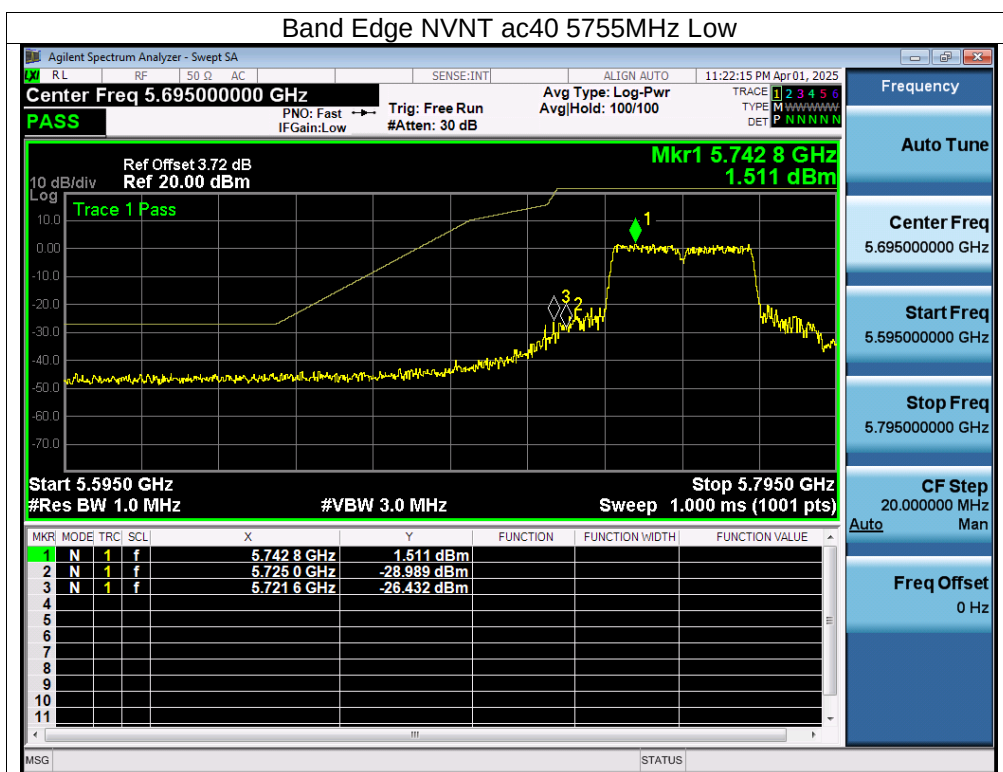


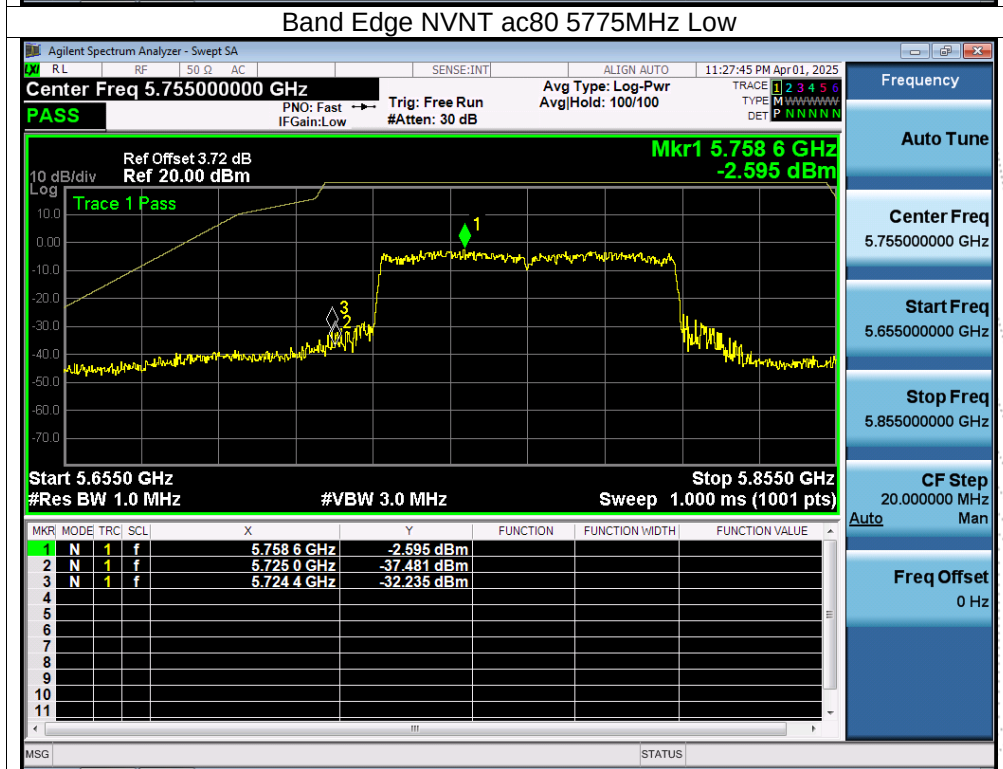
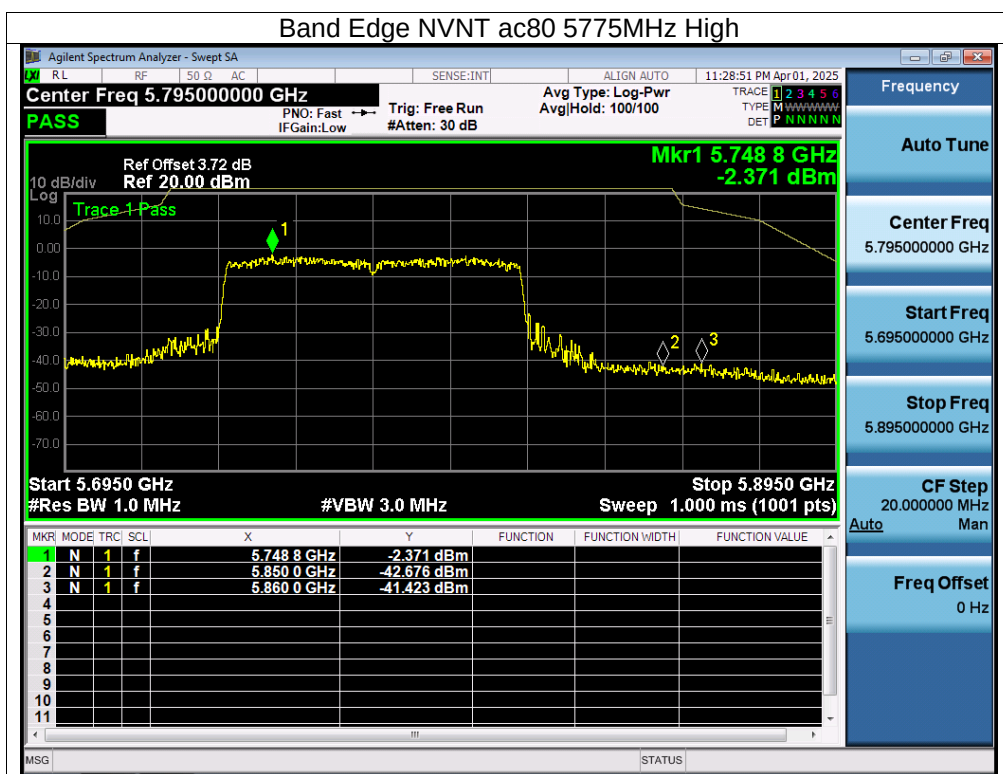












12. Spurious RF Conducted Emissions

12.1 Block Diagram Of Test Setup



12.2 Limit

Undesirable emission limits. Except as shown in paragraph (b)(7) of this section, the maximum emissions outside of the frequency bands of operation shall be attenuated in accordance with the following limits:

(1)For transmitters operating in the 5.15-5.25 GHz band: All emissions outside of the 5.15-5.35 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.

(2)For transmitters operating in the 5.725-5.85 GHz band(i) All emissions shall be limited to a level of -27 dBm/MHz at 75 MHz or more above or below the band edge increasing linearly to 10 dBm/MHz at 25 MHz above or below the band edge, and from 25 MHz above or below the band edge increasing linearly to a level of 15.6 dBm/MHz at 5 MHz above or below the band edge, and from 5 MHz above or below the band edge increasing linearly to a level of 27 dBm/MHz at the band edge..

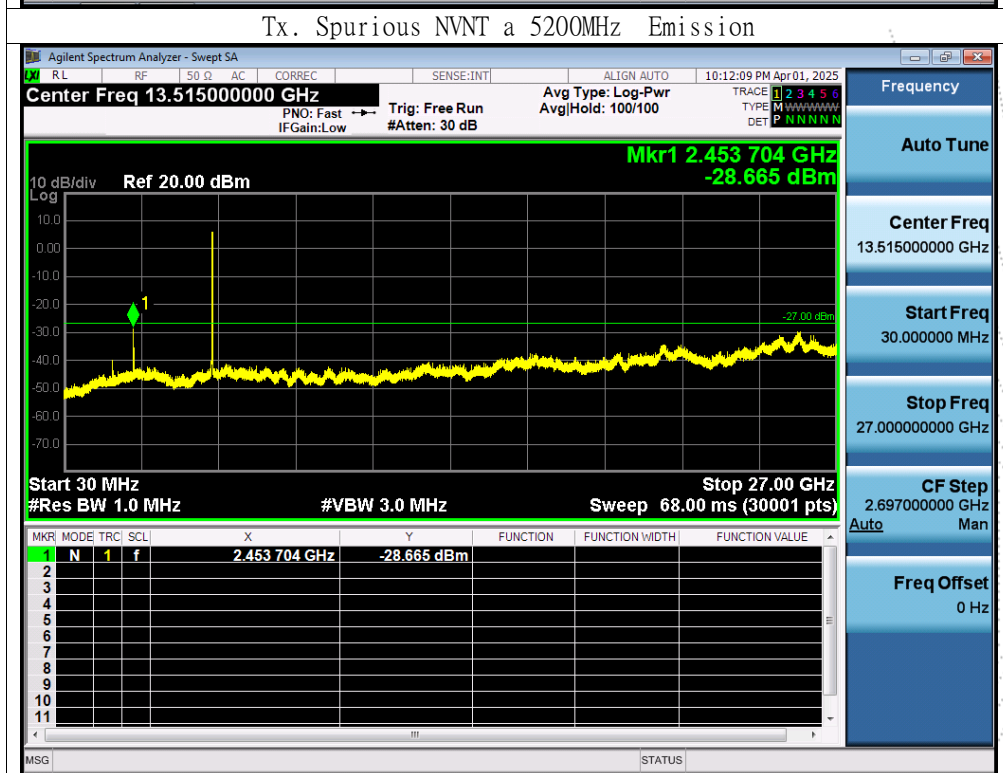
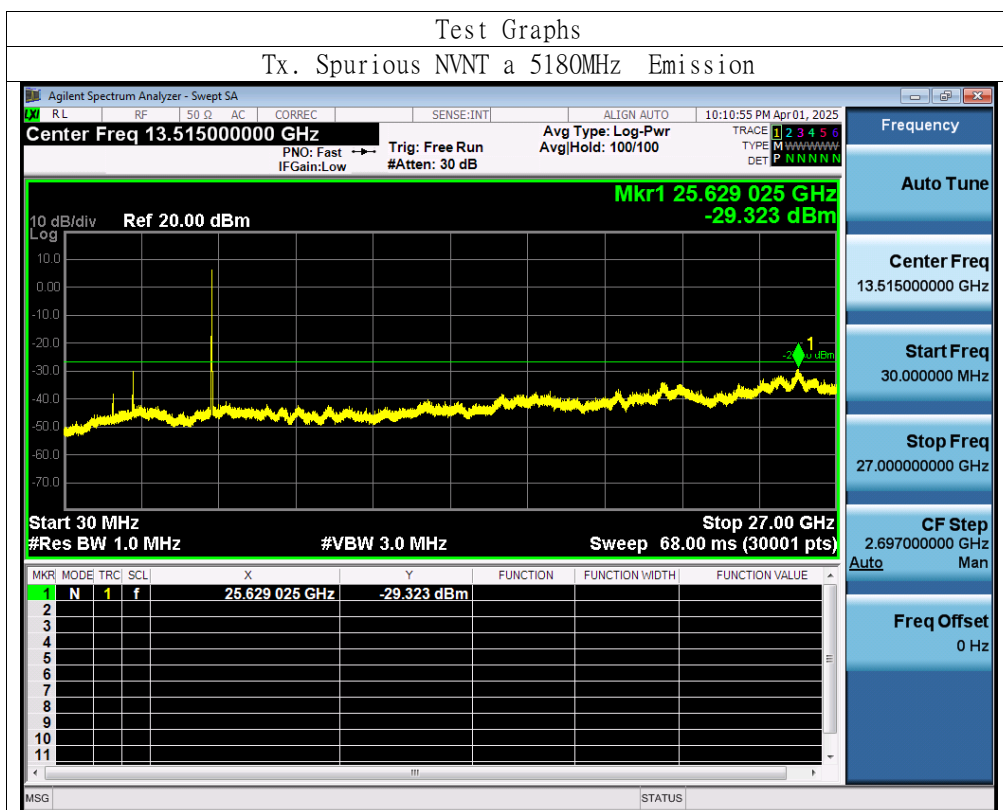
12.3 Test Procedure

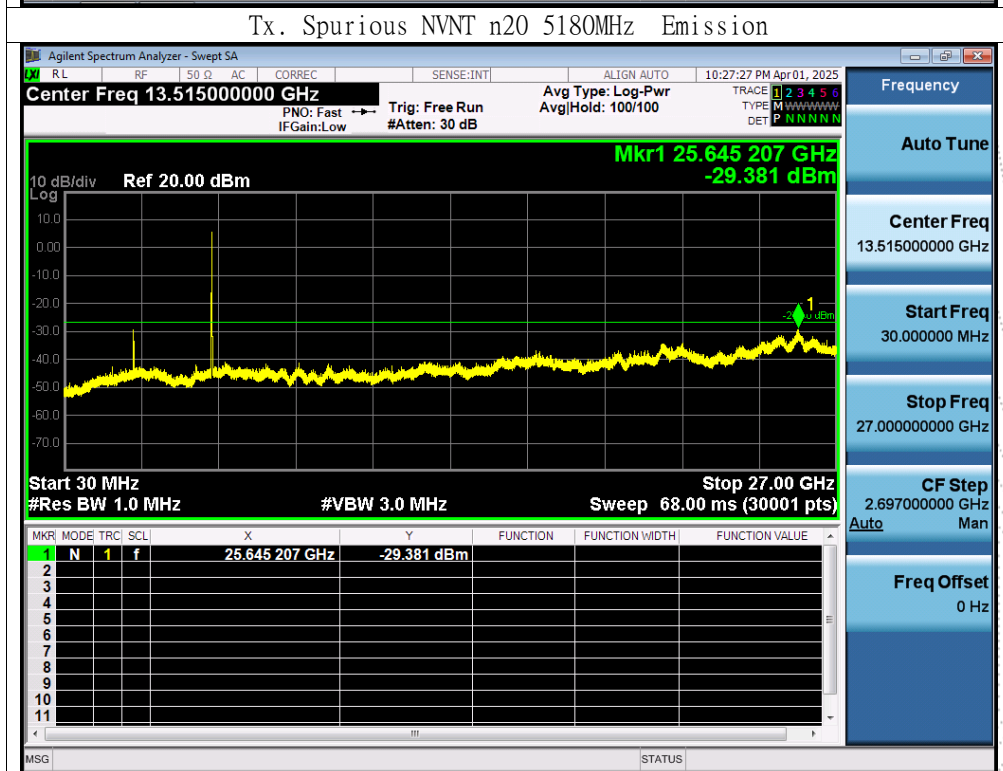
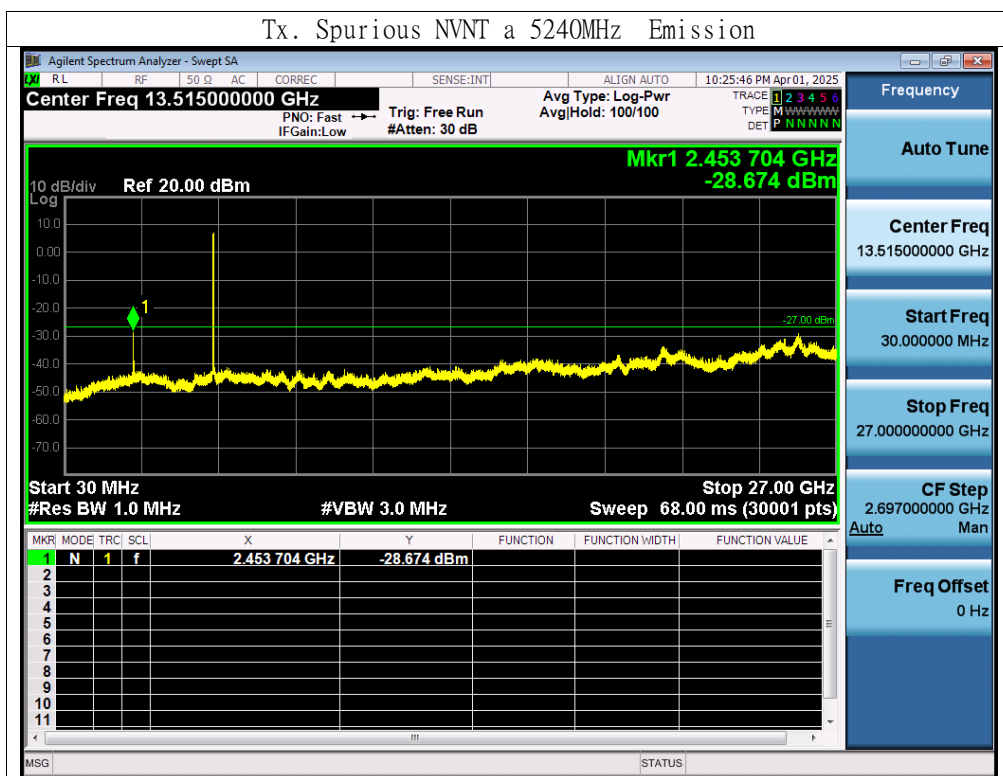
1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set RBW of spectrum analyzer to 1 MHz with a convenient frequency span.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

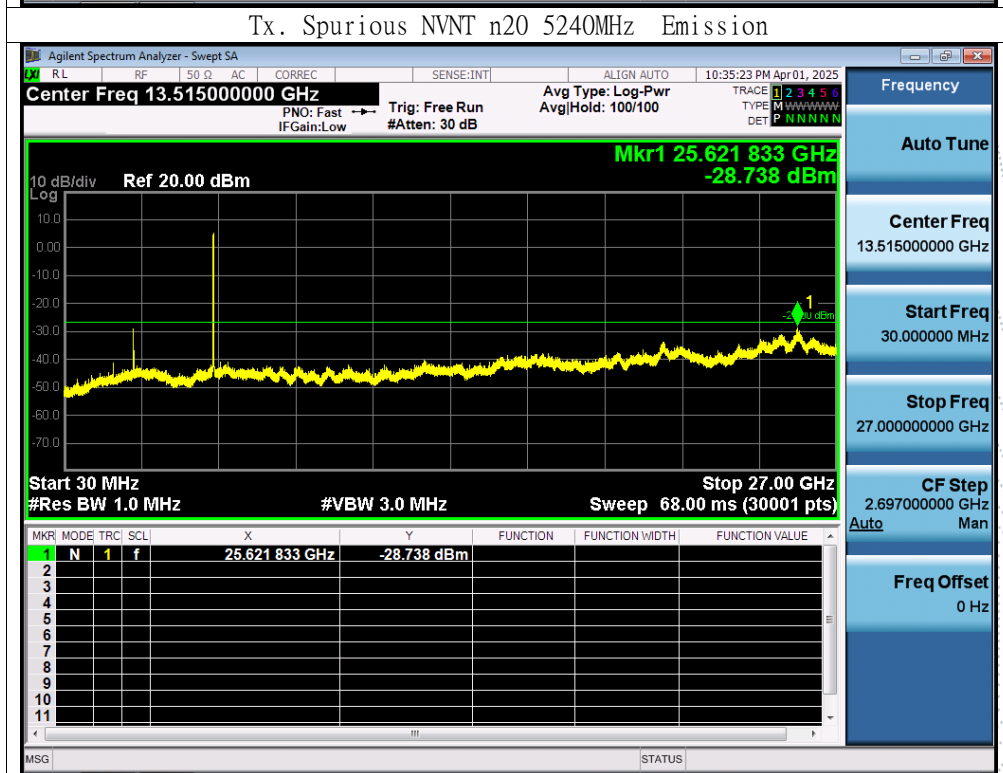
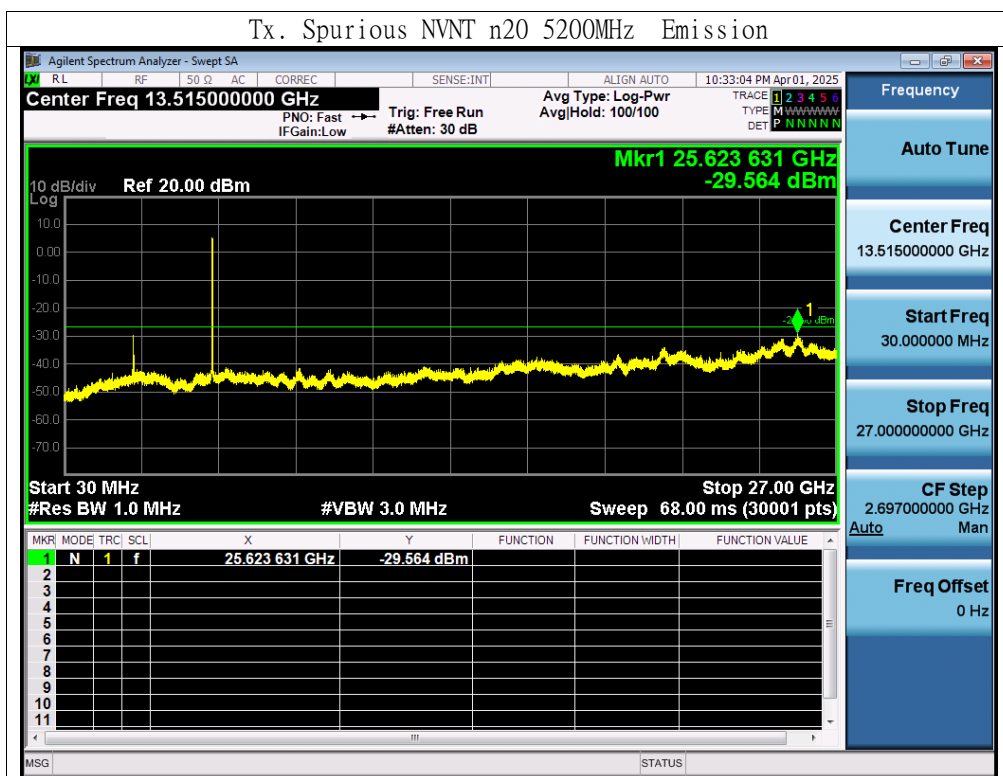
12.4 Test Result

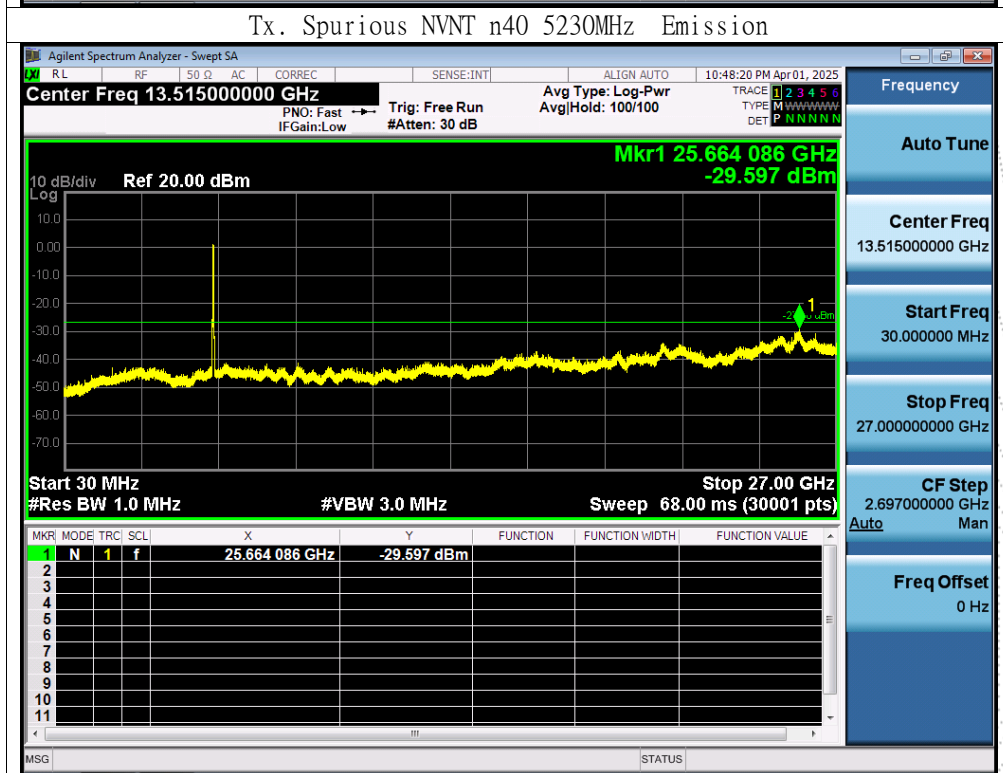
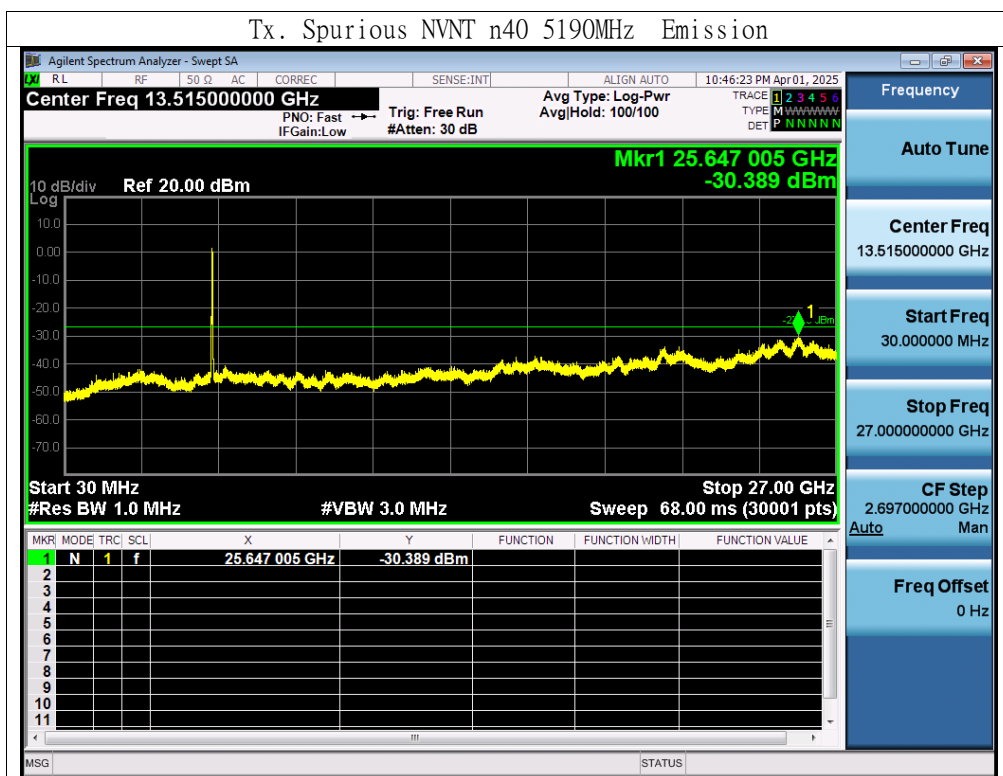
Remark: The measurement frequency range is from 9KHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandedge measurement data.

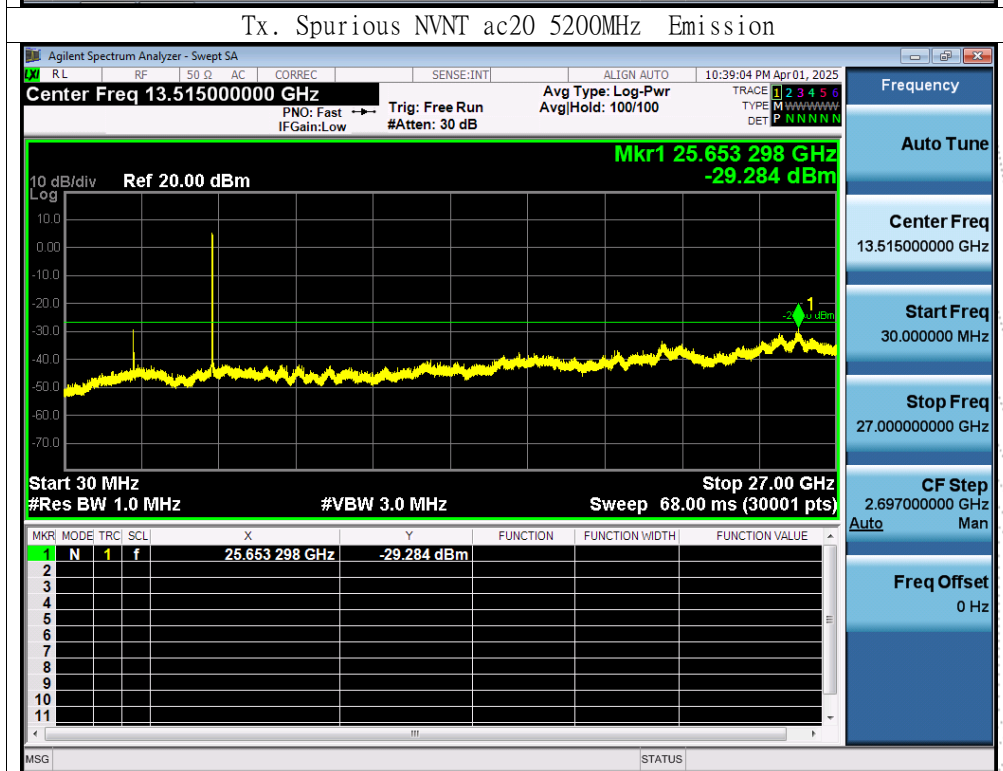
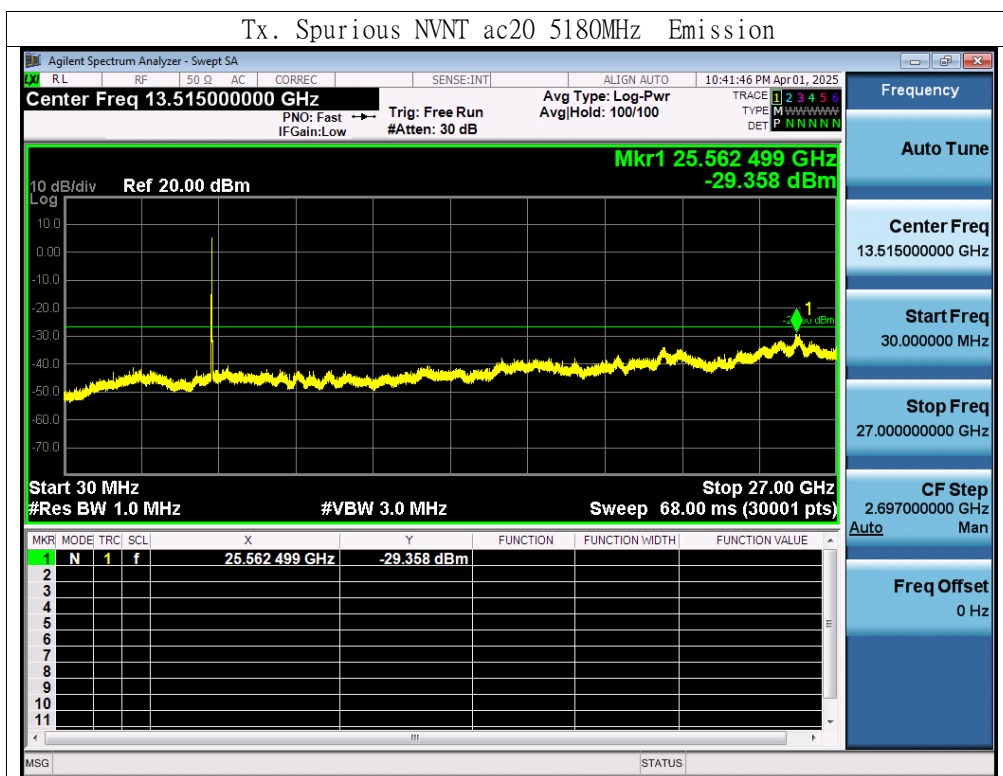
About:26.5GHz-40GHz, The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

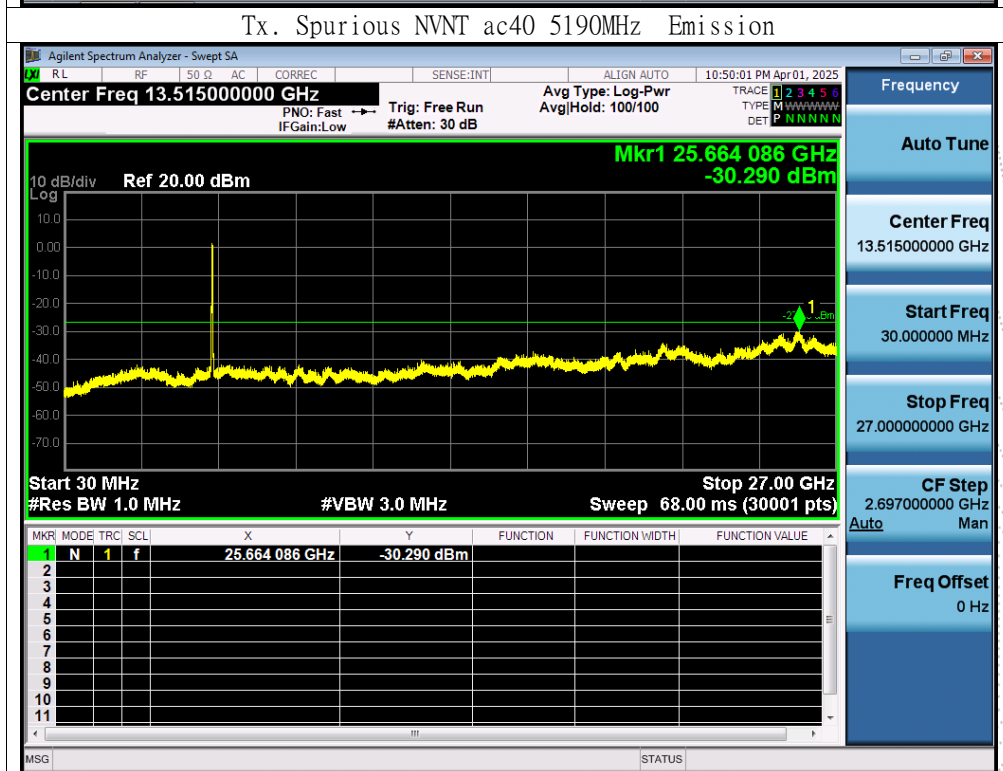
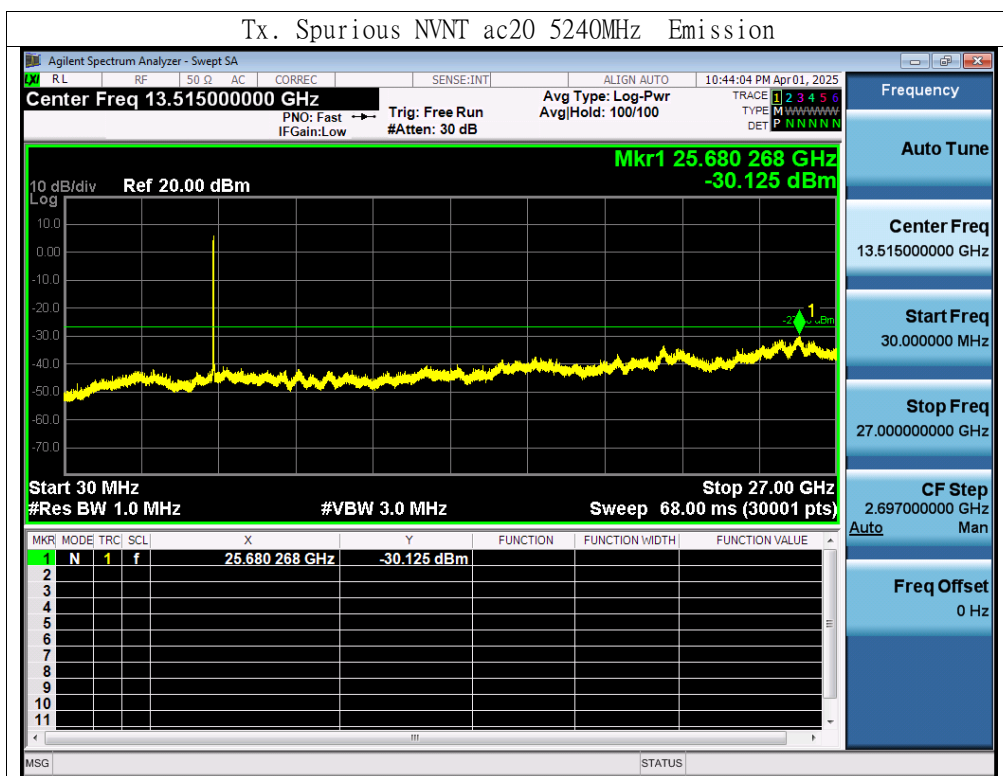


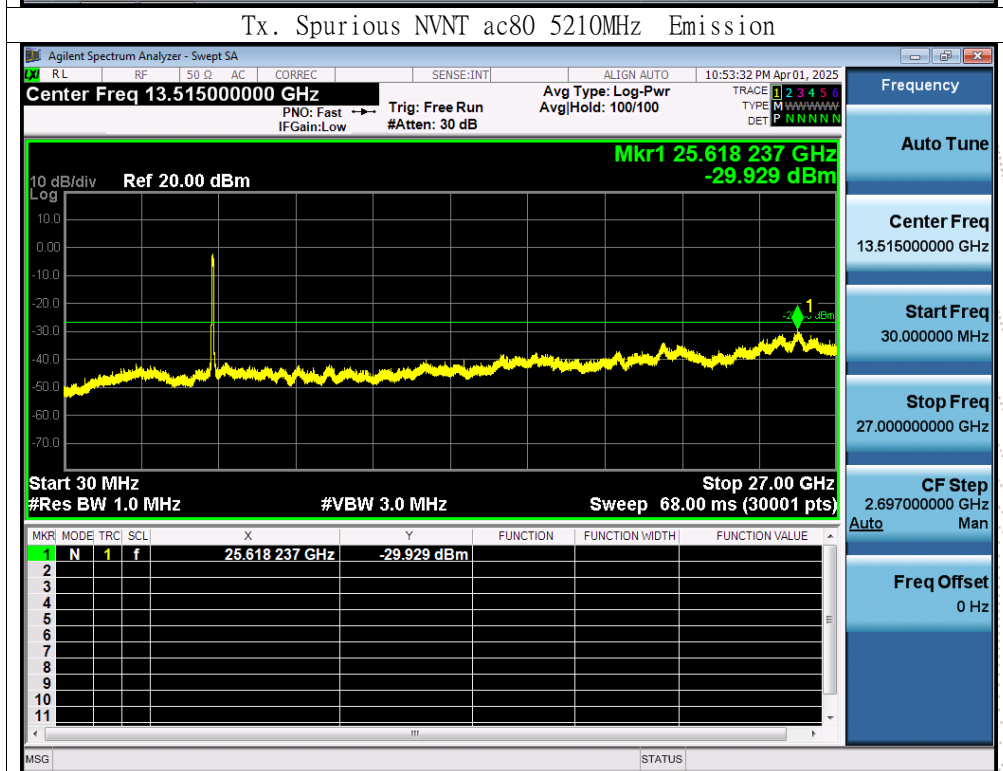
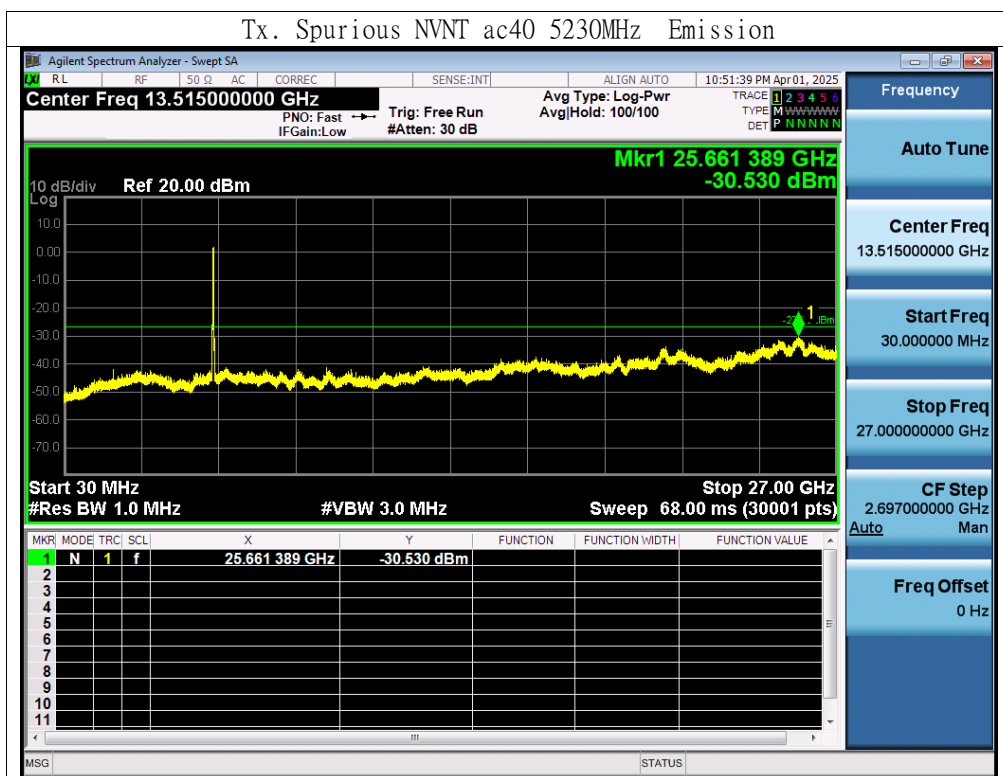


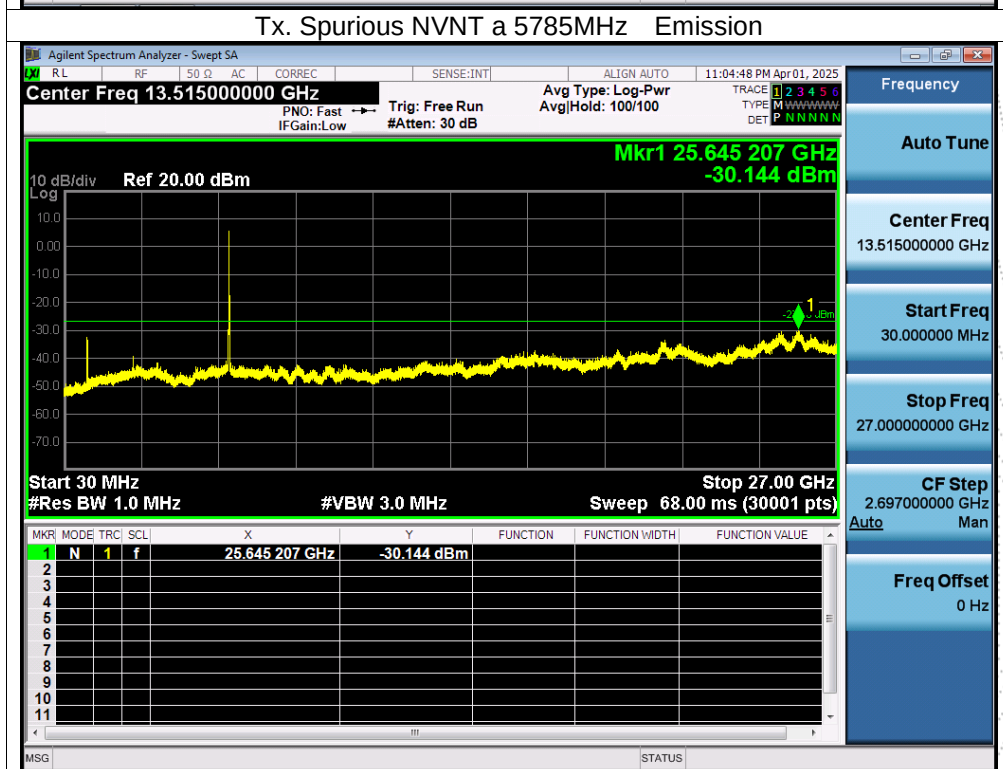
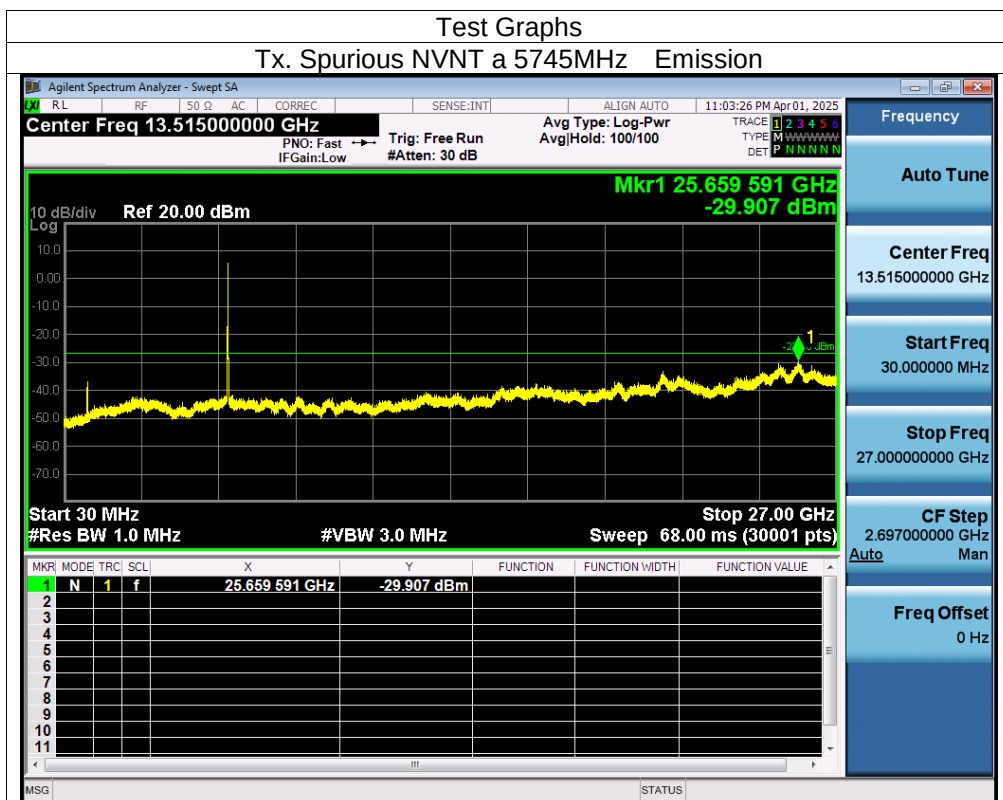


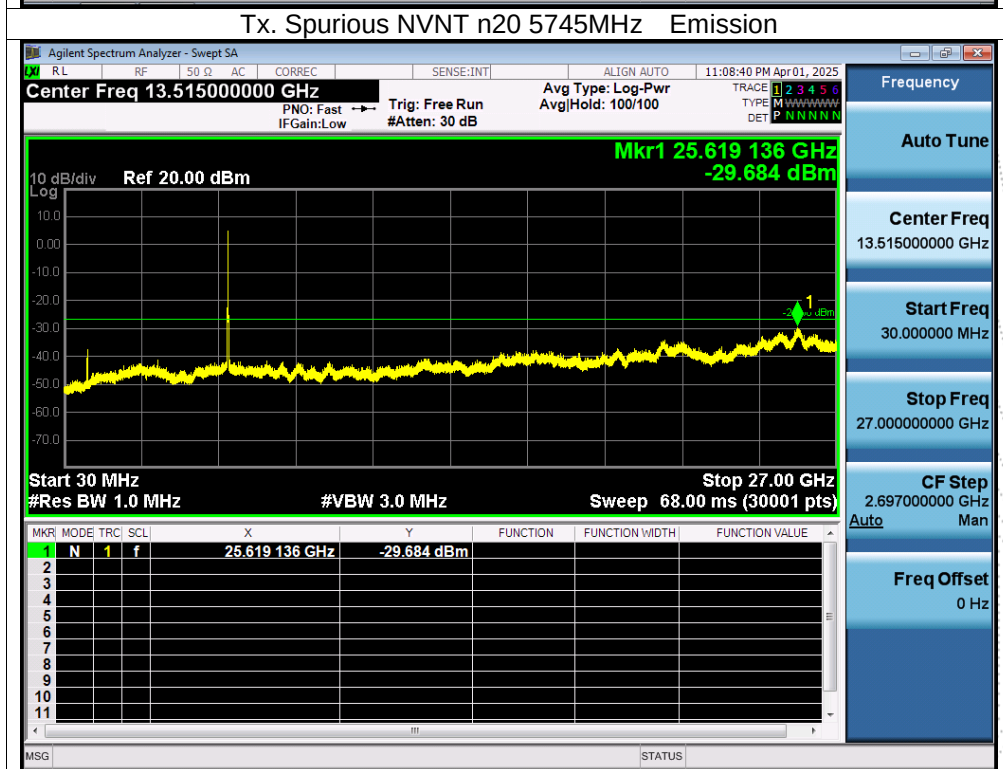
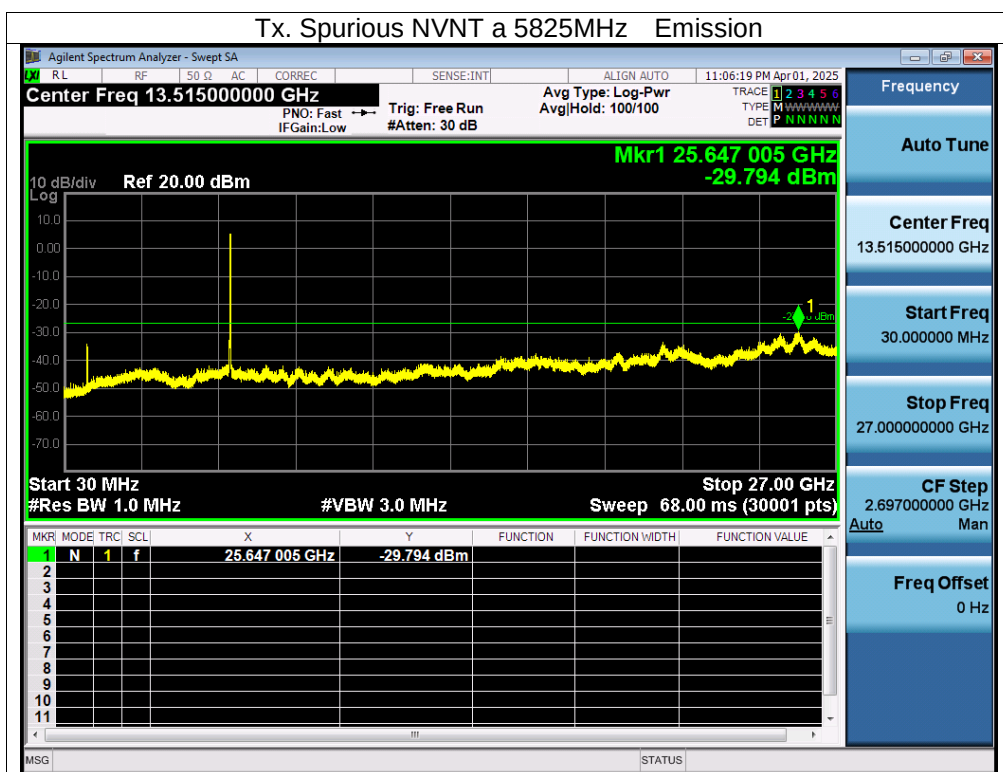


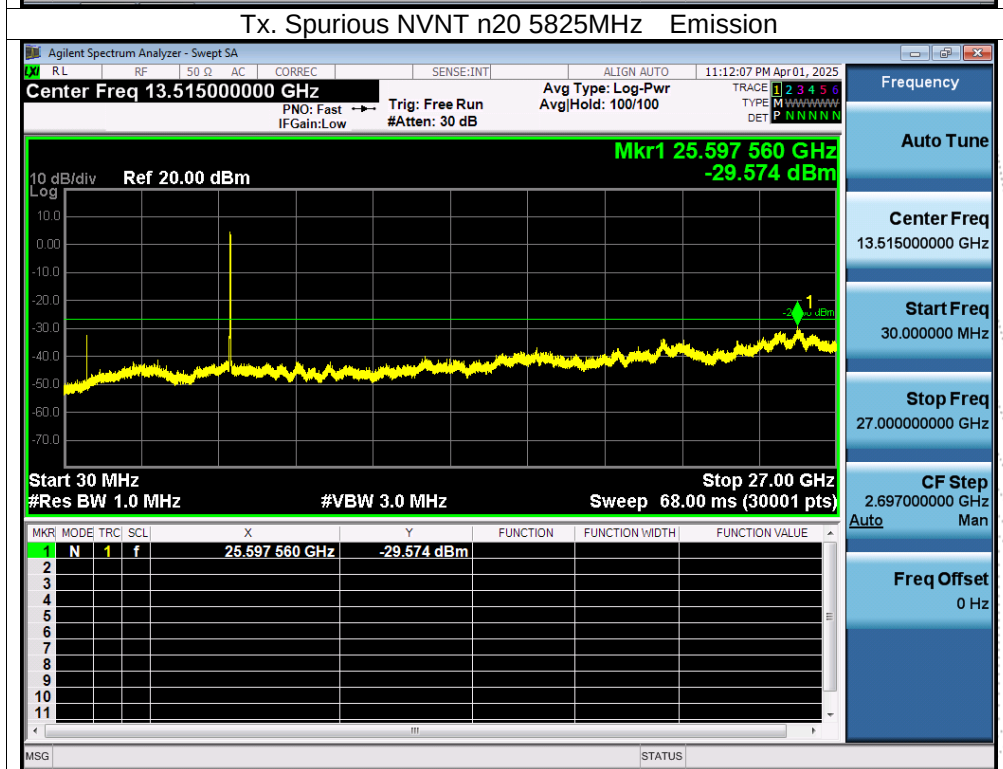
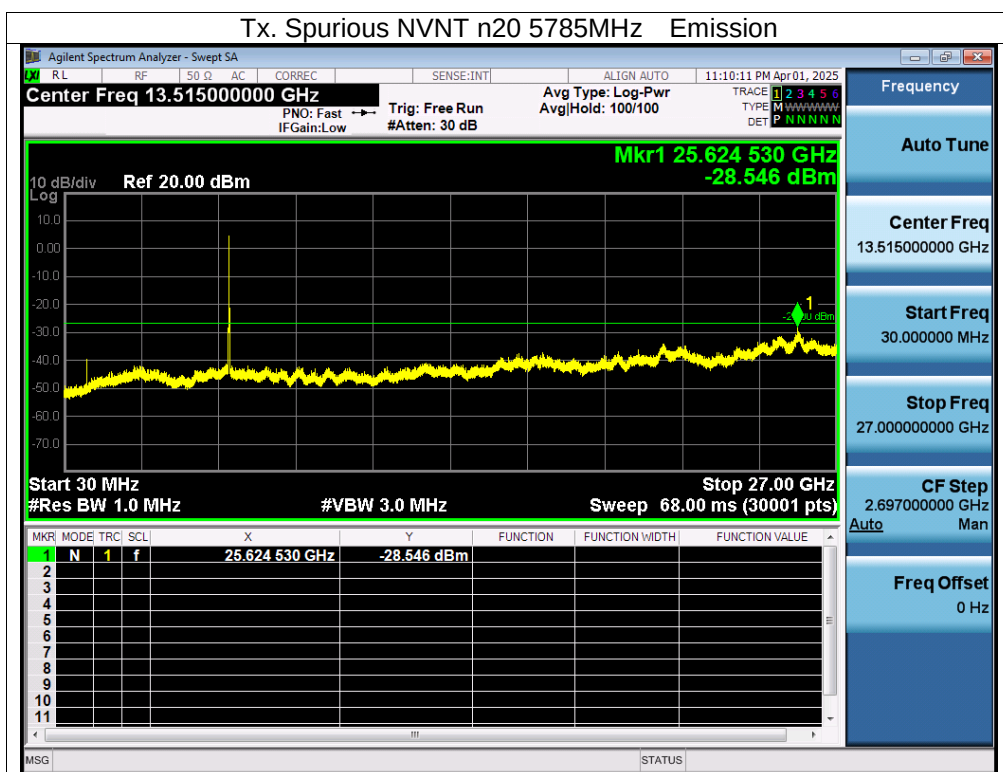


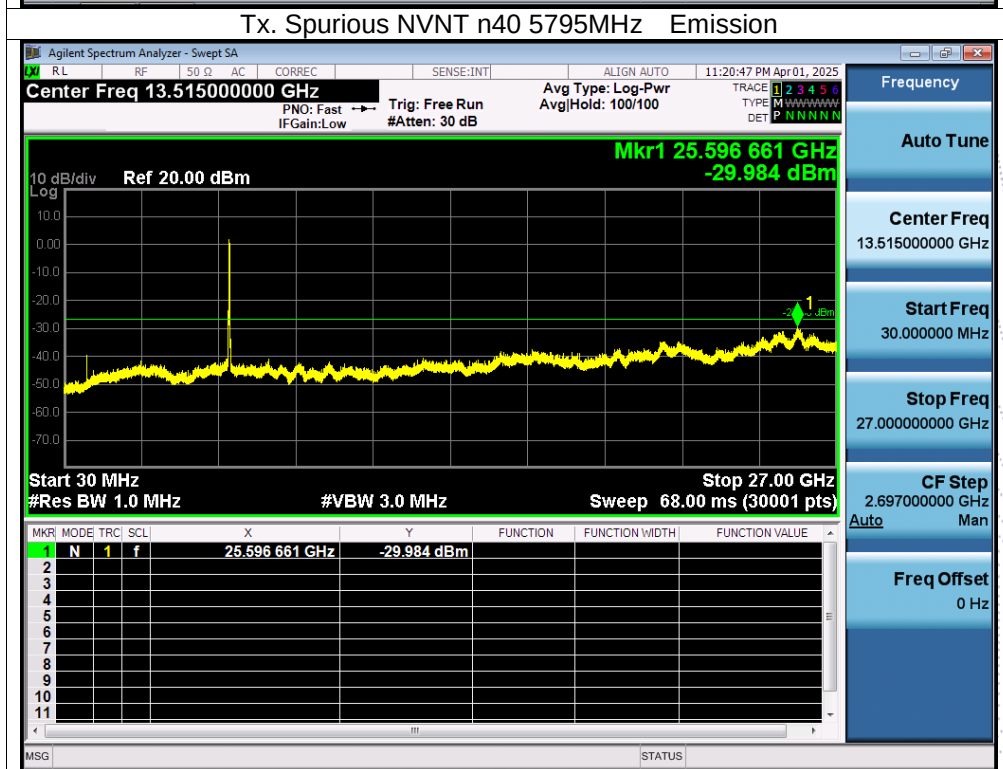
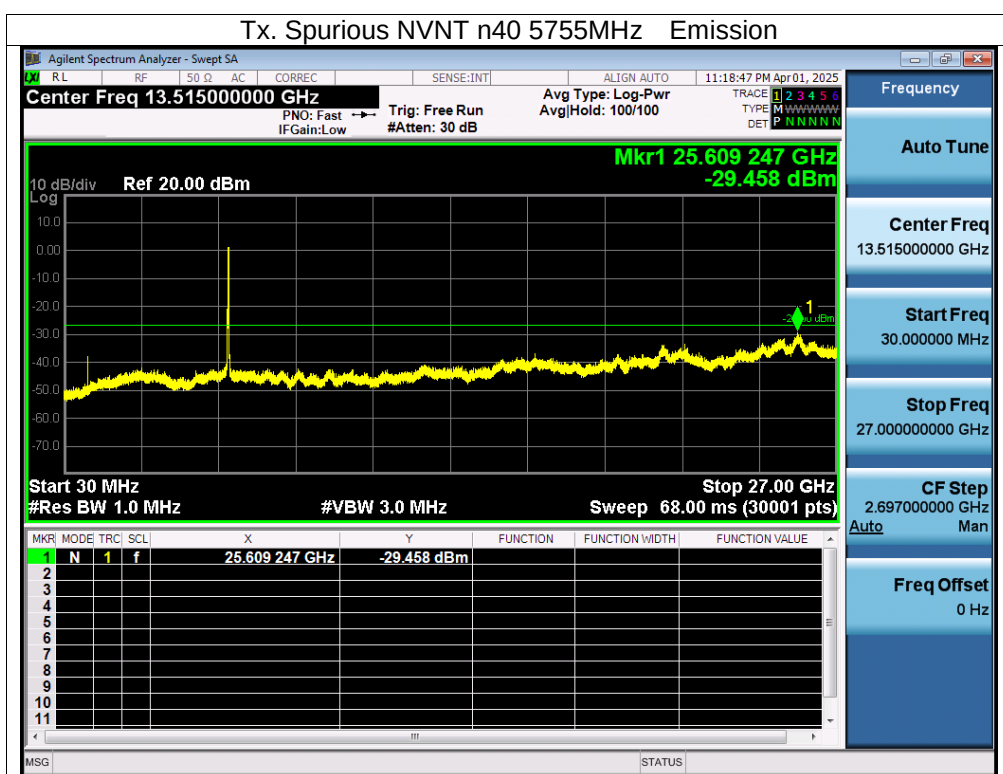


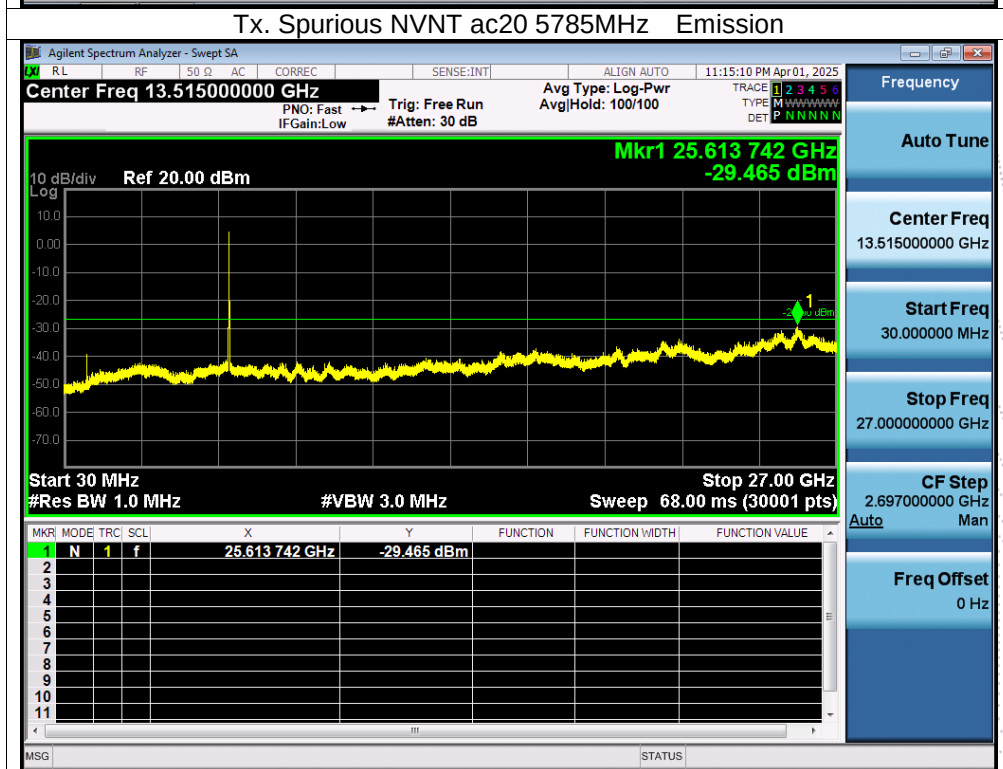
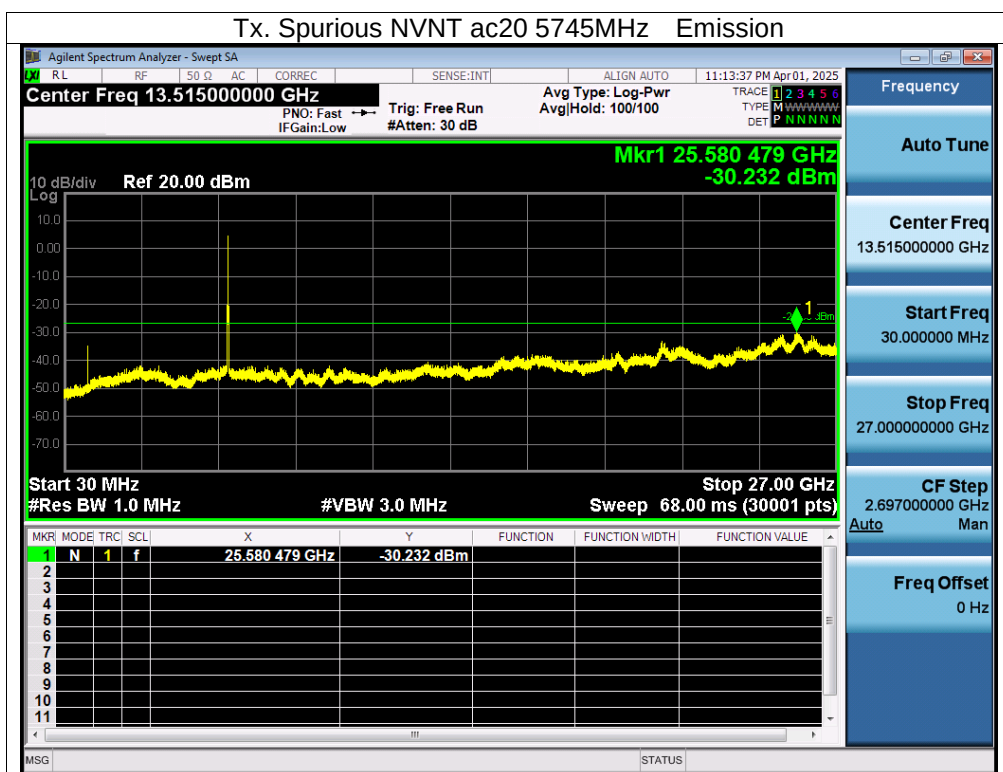


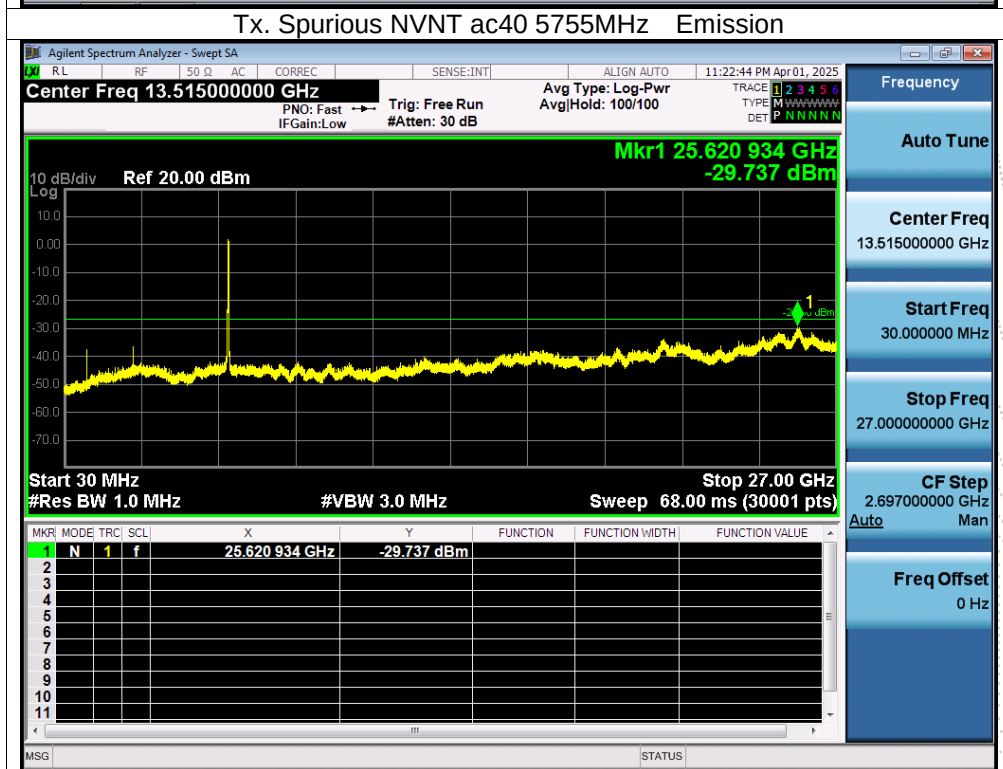
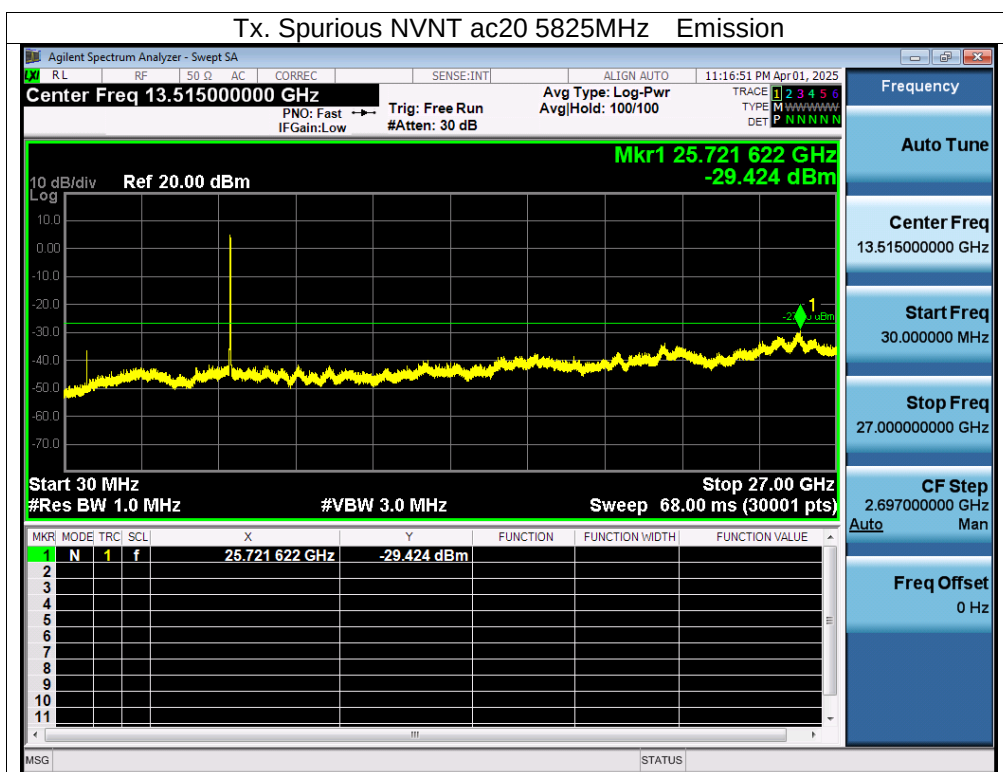


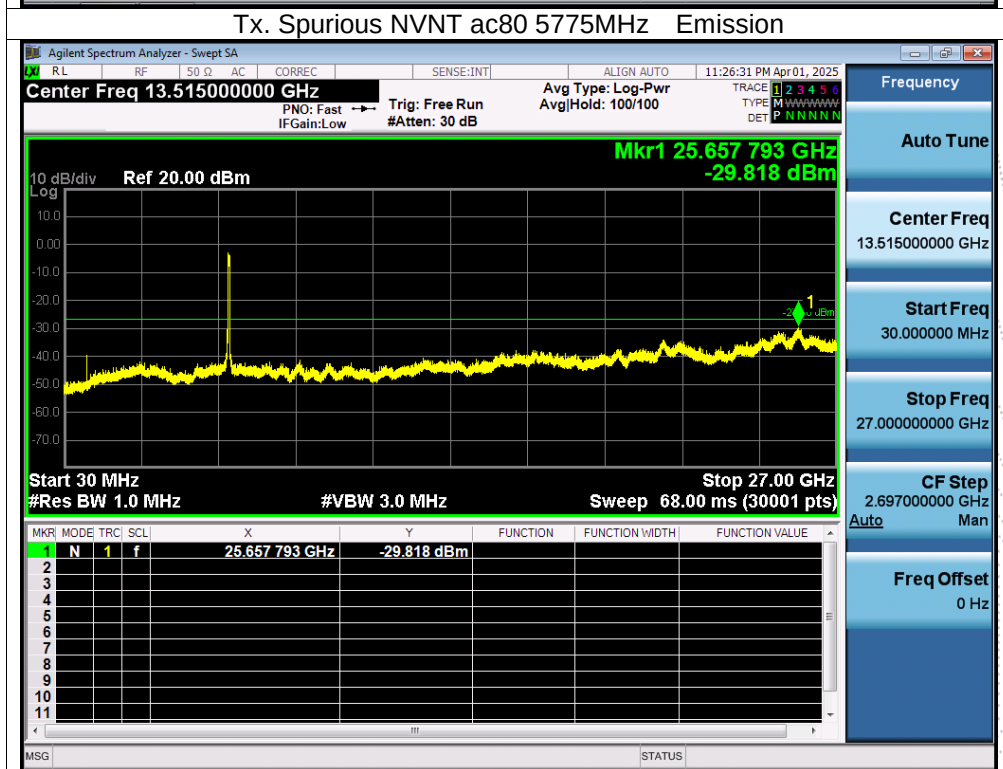
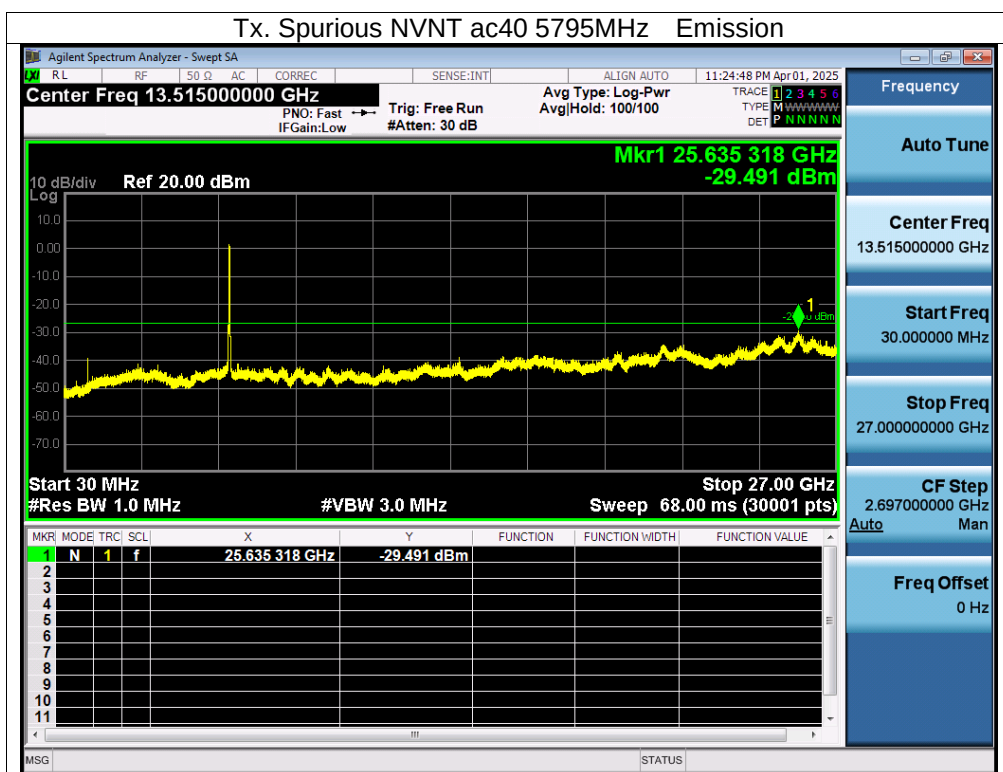












13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f)/f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11nspecification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^{\circ}\text{C} \sim 70^{\circ}\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.87V
Test Mode:	TX Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5180.0099	5180	0.0099	1.9112
		V max (V)	4.45	5180.0032	5180	0.0032	0.6178
		V min (V)	3.29	5180.0016	5180	0.0016	0.3089
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5180.0001	5180	0.0001	0.0193
		T (°C)	-10	5180.0017	5180	0.0017	0.3282
		T (°C)	0	5180.0068	5180	0.0068	1.3127
		T (°C)	10	5180.0094	5180	0.0094	1.8147
		T (°C)	20	5180.0067	5180	0.0067	1.2934
		T (°C)	30	5180.0044	5180	0.0044	0.8494
		T (°C)	40	5180.0039	5180	0.0039	0.7529
		T (°C)	50	5180.0054	5180	0.0054	1.0425
		T (°C)	60	5180.0057	5180	0.0057	1.1004
		T (°C)	70	5180.0072	5180	0.0072	1.3900
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5200.0028	5200	0.0028	0.5385
		V max (V)	4.45	5200.0129	5200	0.0129	2.4808
		V min (V)	3.29	5200.0076	5200	0.0076	1.4615
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5200.00040	5200	0.00040	0.0769
		T (°C)	-10	5200.00070	5200	0.00070	0.1346
		T (°C)	0	5200.00060	5200	0.00060	0.1154
		T (°C)	10	5200.00940	5200	0.00940	1.8077
		T (°C)	20	5200.00050	5200	0.00050	0.0962
		T (°C)	30	5200.00270	5200	0.00270	0.5192
		T (°C)	40	5200.00290	5200	0.00290	0.5577
		T (°C)	50	5200.00220	5200	0.00220	0.4231
		T (°C)	60	5200.00090	5200	0.00090	0.1731
		T (°C)	70	5200.00650	5200	0.00650	1.2500
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5240.0026	5240	0.0026	0.4962
		V max (V)	4.45	5240.0063	5240	0.0063	1.2023
		V min (V)	3.29	5240.0117	5240	0.0117	2.2328
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5240.0026	5240	0.0026	0.4962
		T (°C)	-10	5240.0116	5240	0.0116	2.2137
		T (°C)	0	5240.0115	5240	0.0115	2.1947
		T (°C)	10	5240.0100	5240	0.0100	1.9084
		T (°C)	20	5240.0059	5240	0.0059	1.1260
		T (°C)	30	5240.0033	5240	0.0033	0.6298
		T (°C)	40	5240.0120	5240	0.0120	2.2901
		T (°C)	50	5240.0133	5240	0.0133	2.5382
		T (°C)	60	5240.0001	5240	0.0001	0.0191
		T (°C)	70	5240.0031	5240	0.0031	0.5916
Limits				5150-5250 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.87V
Test Mode:	TX Frequency(5745-5825MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5745.00380	5745	0.00380	0.6614
		V max (V)	4.45	5745.01350	5745	0.01350	2.3499
		V min (V)	3.29	5745.00690	5745	0.00690	1.2010
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5745.01310	5745	0.01310	2.2802
		T (°C)	-10	5745.00810	5745	0.00810	1.4099
		T (°C)	0	5745.00060	5745	0.00060	0.1044
		T (°C)	10	5745.00210	5745	0.00210	0.3655
		T (°C)	20	5745.00810	5745	0.00810	1.4099
		T (°C)	30	5745.00110	5745	0.00110	0.1915
		T (°C)	40	5745.00510	5745	0.00510	0.8877
		T (°C)	50	5745.00230	5745	0.00230	0.4003
		T (°C)	60	5745.00720	5745	0.00720	1.2533
		T (°C)	70	5745.00440	5745	0.00440	0.7659
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5785.00020	5785	0.00020	0.0346
		V max (V)	4.45	5785.00820	5785	0.00820	1.4175
		V min (V)	3.29	5785.00840	5785	0.00840	1.4520
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5785.01080	5785	0.01080	1.8669
		T (°C)	-10	5785.00430	5785	0.00430	0.7433
		T (°C)	0	5785.01070	5785	0.01070	1.8496
		T (°C)	10	5785.00390	5785	0.00390	0.6742
		T (°C)	20	5785.01150	5785	0.01150	1.9879
		T (°C)	30	5785.00000	5785	0.00000	0.0000
		T (°C)	40	5785.01070	5785	0.01070	1.8496
		T (°C)	50	5785.00340	5785	0.00340	0.5877
		T (°C)	60	5785.01180	5785	0.01180	2.0398
		T (°C)	70	5785.01170	5785	0.01170	2.0225
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.87	5825.00440	5825	0.00440	0.7554
		V max (V)	4.45	5825.00880	5825	0.00880	1.5107
		V min (V)	3.29	5825.00990	5825	0.00990	1.6996
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.87	T (°C)	-20	5825.01030	5825	0.01030	1.7682
		T (°C)	-10	5825.01220	5825	0.01220	2.0944
		T (°C)	0	5825.00280	5825	0.00280	0.4807
		T (°C)	10	5825.00500	5825	0.00500	0.8584
		T (°C)	20	5825.00090	5825	0.00090	0.1545
		T (°C)	30	5825.00020	5825	0.00020	0.0343
		T (°C)	40	5825.01220	5825	0.01220	2.0944
		T (°C)	50	5825.00800	5825	0.00800	1.3734
		T (°C)	60	5825.00870	5825	0.00870	1.4936
		T (°C)	70	5825.00840	5825	0.00840	1.4421
Limits				5725-5850 MHz			
Result				Complies			

14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

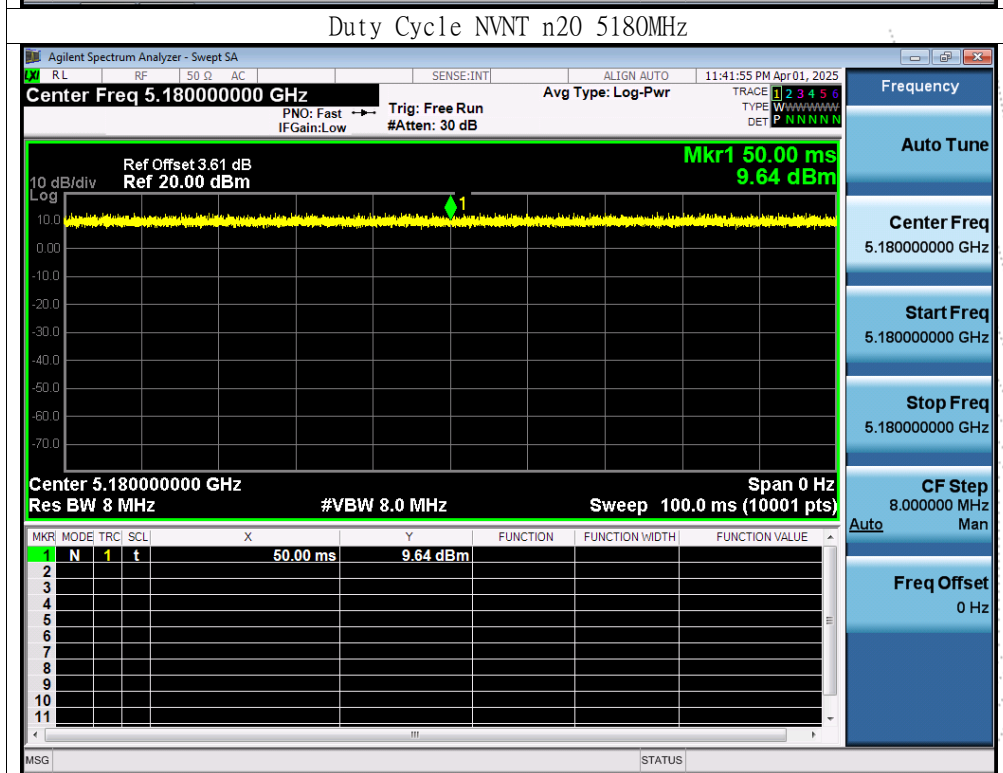
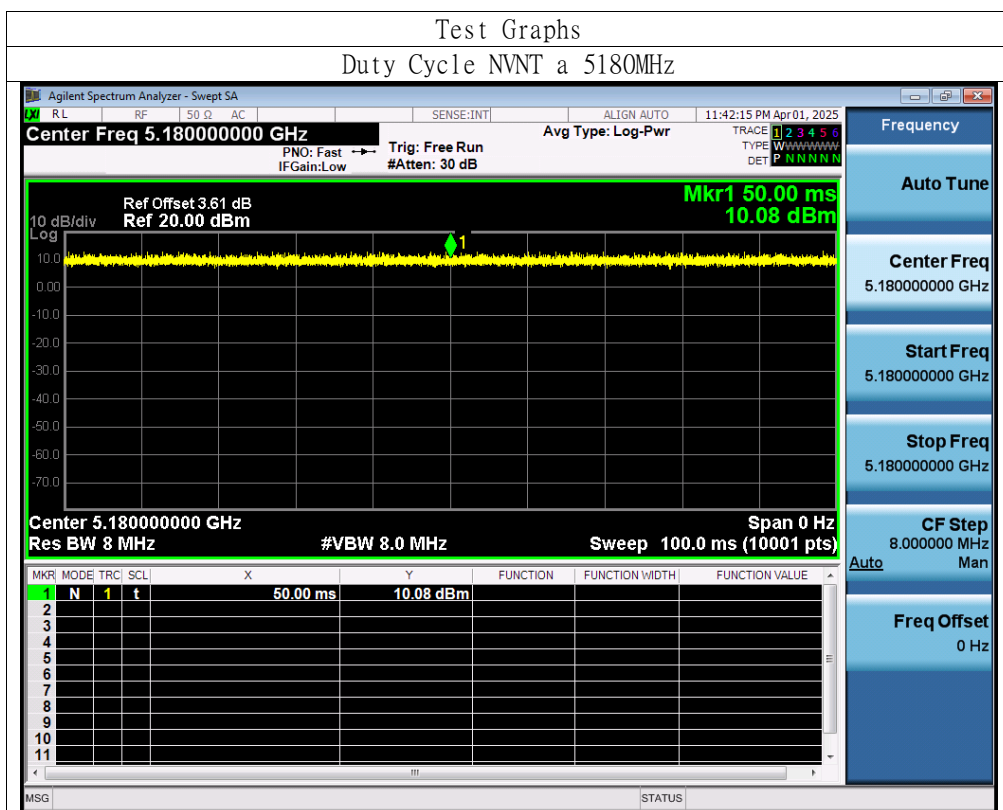
14.3 Test Procedure

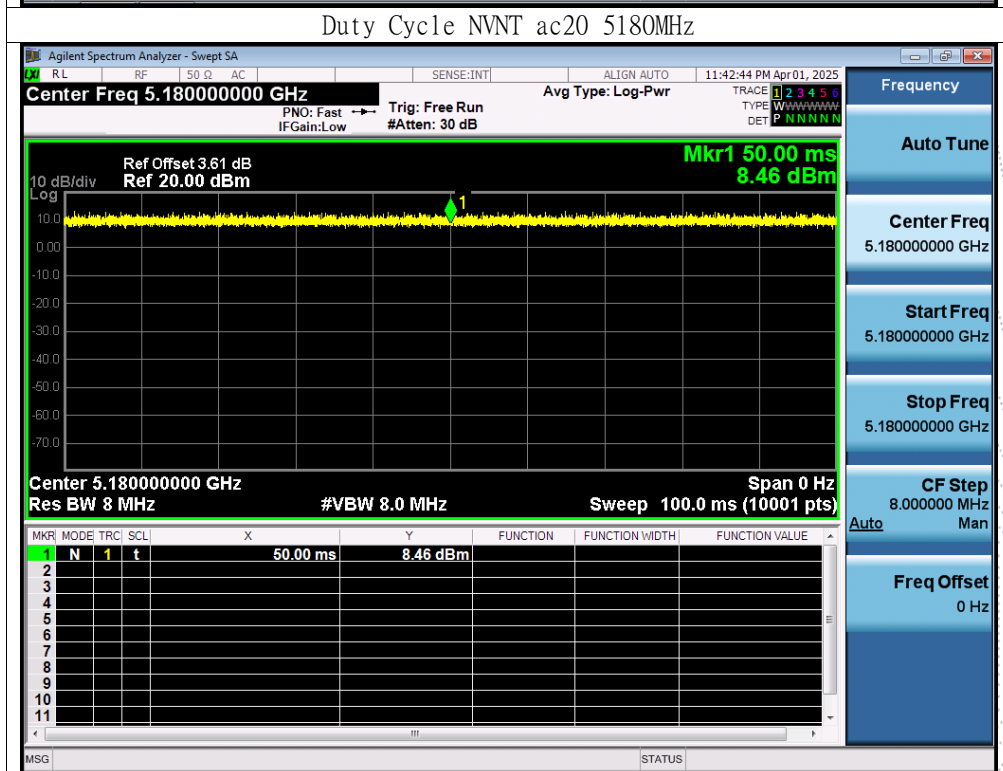
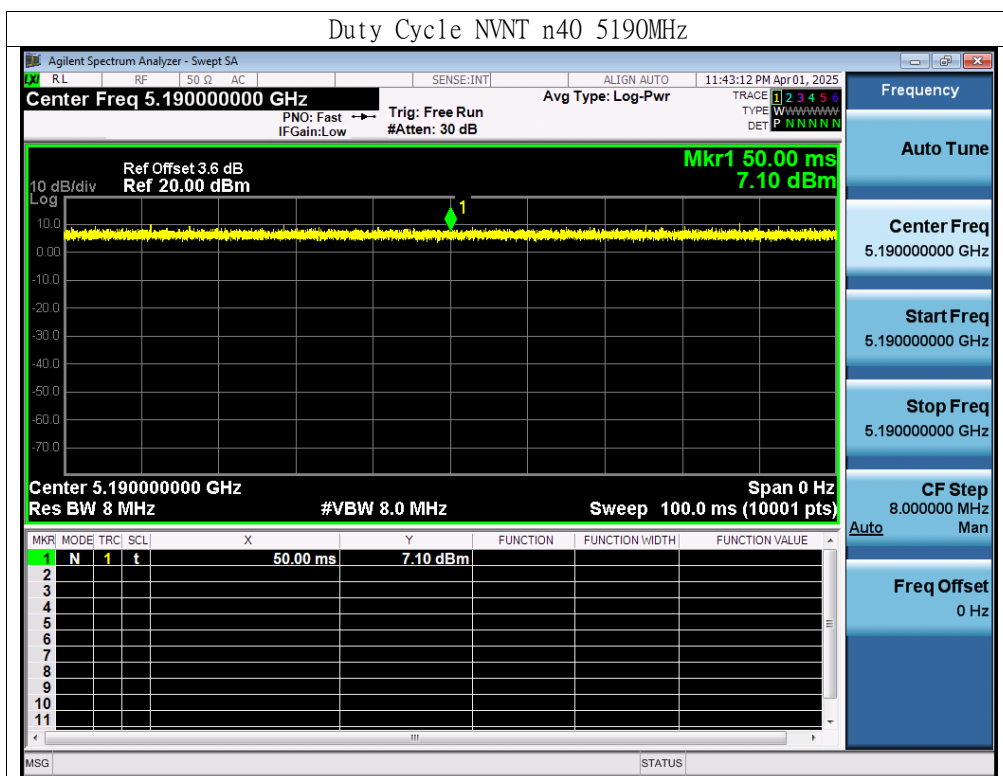
1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

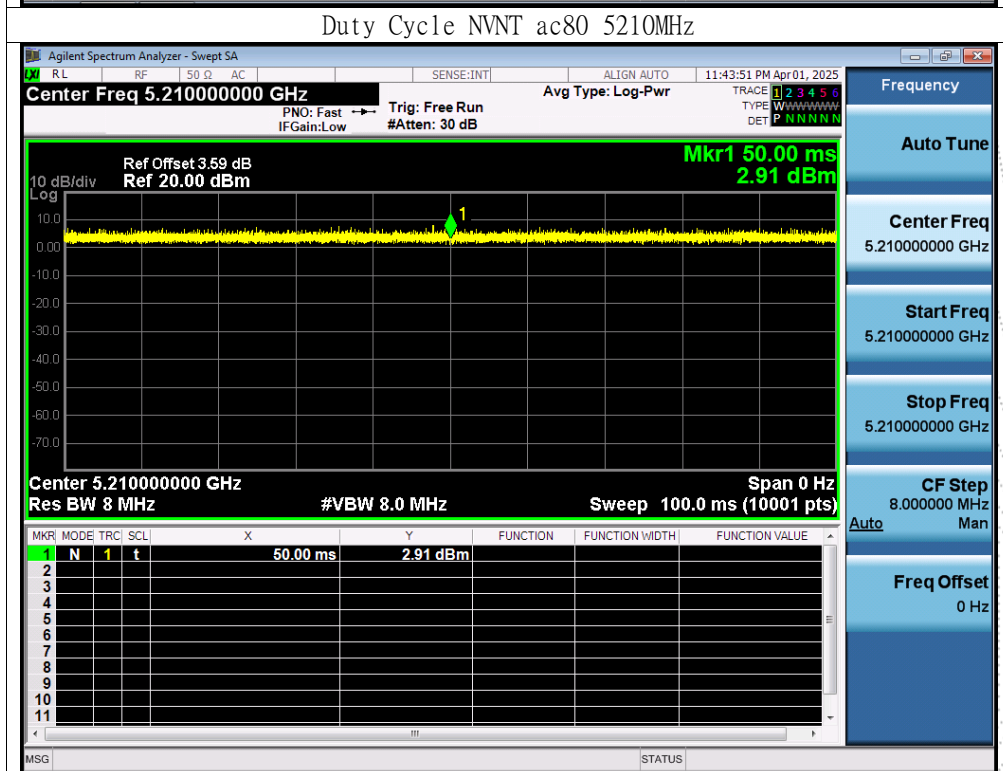
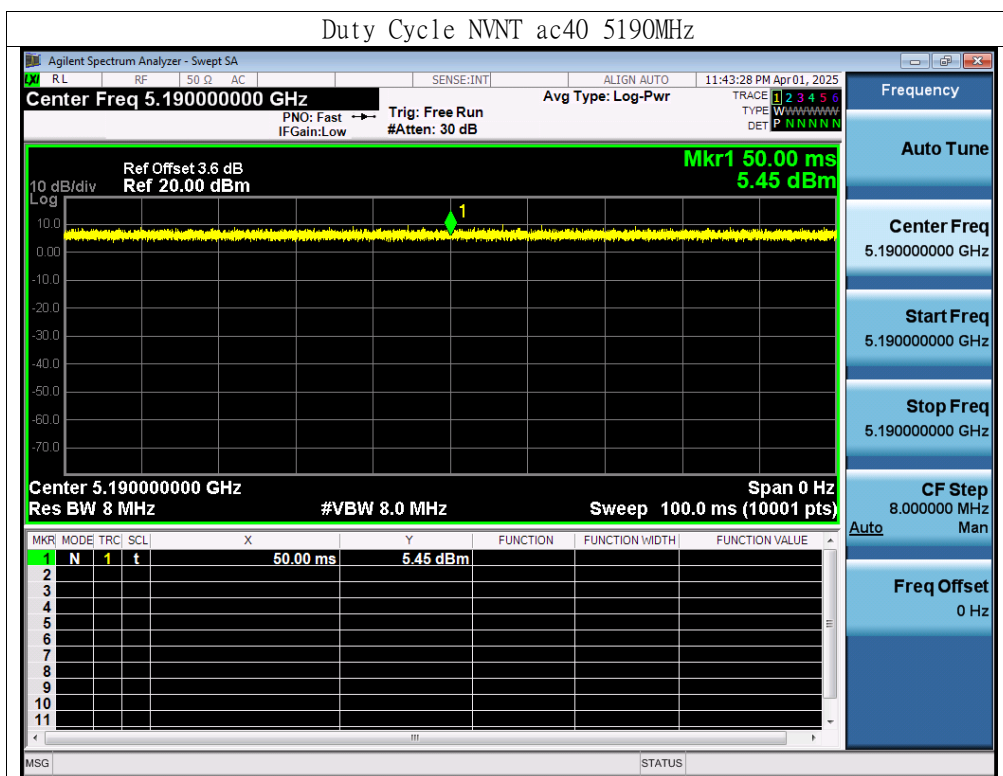
14.4 Test Result

5.1G

Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5180	100	0	0
NVNT	n20	5180	100	0	0
NVNT	n40	5190	100	0	0
NVNT	ac20	5180	100	0	0
NVNT	ac40	5190	100	0	0
NVNT	ac80	5210	100	0	0







5.8G

Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5745	100	0	0
NVNT	n20	5745	100	0	0
NVNT	n40	5755	100	0	0
NVNT	ac20	5745	100	0	0
NVNT	ac40	5755	100	0	0
NVNT	ac80	5775	100	0	0

